





DAC53004W, DAC63004W SLASF72 – MARCH 2023

DACx3004W 12-Bit and 10-Bit, Ultra-Low-Power, Quad Voltage and Current Output Smart DACs With Auto-Detected I²C, SPI, or PMBus Interface

1 Features

TEXAS

- Programmable voltage or current outputs with flexible configuration:
 - Voltage outputs:

INSTRUMENTS

- 1 LSB DNL
- Gains of 1 ×, 1.5 ×, 2 ×, 3 ×, and 4 ×
- Current outputs:
 - 1 LSB INL and DNL (8-bit)
 - Unipolar and bipolar output range options from 25 µA to 250 µA
- 35-µA/channel I_{DD} in voltage-output mode
- Programmable comparator mode for all channels
- · High-impedance output when VDD is off
- High-impedance and resistive pulldown powerdown modes
- 50-MHz SPI-compatible interface
- Automatically detected I²C, SPI, or PMBus[™] interface
 - 1.62-V V_{IH} with V_{DD} = 5.5 V
- General-purpose input/output (GPIO) configurable
 as multiple functions
- Predefined waveform generation: sine wave, triangular, sawtooth
- User-programmable nonvolatile memory (NVM)
- Internal, external, or power-supply as reference
- Wide operating range:
 - Power supply: 1.8 V to 5.5 V
 - Temperature range: -40°C to +125°C
- Tiny package: 16-pin DSBGA (1.75 mm × 1.75 mm)

2 Applications

- Optical module
- Pulse oximeter
- Standard notebook PC

3 Description

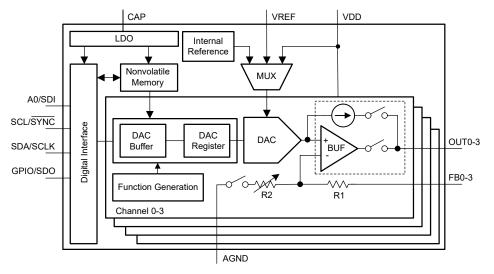
The 12-bit DAC63004W and 10-bit DAC53004W (DACx3004W) are a pin-compatible family of quadchannel, buffered, voltage-output and current-output smart digital-to-analog converters (DACs). These DACx3004W support Hi-Z power-down mode and Hi-Z output during power-off condition. The DAC outputs provide a force-sense option for use as a programmable comparator and current sink. The multifunction GPIO, function generation, and NVM enable these smart DACs for processor-less applications and design reuse. These devices automatically detect I²C, SPI, and PMBus interfaces, and contain an internal reference.

The feature set combined with the tiny package and low power make these smart DACs an excellent choice for applications such as voltage margining and scaling, dc set-point for biasing and calibration, and waveform generation.

Device Information

| | Device information | | | | | | |
|-------------|--------------------|------------------------|--|--|--|--|--|
| PART NUMBER | RESOLUTION | PACKAGE ⁽¹⁾ | | | | | |
| DAC63004W | 12-bit | YBH (DSBGA, 16) | | | | | |
| DAC53004W | 10-bit | YBH (DSBGA, 16) | | | | | |

(1) For all available packages, see the orderable addendum at the end of the data sheet.



Simplified Block Diagram



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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

| DATE | REVISION | NOTES |
|------------|----------|-----------------|
| March 2023 | * | Initial Release |



5 Pin Configuration and Functions

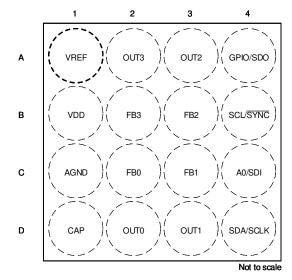


Figure 5-1. YBH Package, 16-pin DSBGA (Top View)

Table 5-1. Pin Functions

| | PIN TYPE | | DESCRIPTION |
|-----|----------|--------------|---|
| NO. | NAME | | DESCRIPTION |
| A1 | VREF | Power | External reference input. Connect a capacitor (approximately 0.1 μ F) between VREF and AGND. Use a pullup resistor to VDD when the external reference is not used. Do not ramp up this pin before VDD. In case an external reference is used, make sure the reference ramps up after VDD. |
| A2 | OUT3 | Output | Analog output voltage from DAC channel 3. |
| A3 | OUT2 | Output | Analog output voltage from DAC channel 2. |
| A4 | GPIO/SDO | Input/Output | General-purpose input/output configurable as <u>LDAC</u> , <u>PD</u> , <u>PROTECT</u> , <u>RESET</u> , SDO, and <u>STATUS</u> . For <u>STATUS</u> and SDO, connect the pin to the IO voltage with an external pullup resistor. If unused, connect the GPIO pin to VDD or AGND using an external resistor. This pin can ramp up before VDD. |
| B1 | VDD | Power | Supply voltage. |
| B2 | FB3 | Input | Voltage feedback pin for channel 3. In voltage-output mode, connect to OUT3 for closed-loop amplifier output. In current-output mode, keep the FB3 pin unconnected to minimize leakage current. |
| B3 | FB2 | Input | Voltage feedback pin for channel 2. In voltage-output mode, connect to OUT2 for closed-loop amplifier output. In current-output mode, keep the FB2 pin unconnected to minimize leakage current. |
| B4 | SCL/SYNC | Output | I ² C serial interface clock or SPI chip select input. Connect this to the IO voltage using an external pullup resistor. This pin can ramp up before VDD. |
| C1 | AGND | Ground | Ground reference point for all circuitry on the device. |
| C2 | FB0 | Input | Voltage feedback pin for channel 0. In voltage-output mode, connect to OUT0 for closed-loop amplifier output. In current-output mode, keep the FB0 pin unconnected to minimize leakage current. |
| C3 | FB1 | Input | Voltage feedback pin for channel 1. In voltage-output mode, connect to OUT1 for closed-loop amplifier output. In current-output mode, keep the FB1 pin unconnected to minimize leakage current. |
| C4 | A0/SDI | Input | Address configuration pin for I ² C or serial data input for SPI. For A0, connect this pin to VDD, AGND, SDA, or SCL for address configuration (Section 7.5.2.2.1). For SDI, this pin need not be pulled up or pulled down. This pin can ramp up before VDD. |
| D1 | CAP | Power | External bypass capacitor for the internal LDO. Connect a capacitor (approximately 1.5 $\mu F)$ between CAP and AGND. |
| D2 | OUT0 | Output | Analog output voltage from DAC channel 0. |
| D3 | OUT1 | Output | Analog output voltage from DAC channel 1. |
| D4 | SDA/SCLK | Input/Output | Bidirectional I ² C serial data bus or SPI clock input. Connect this pinto the IO voltage using an external pullup resistor in I ² C mode. This pin can ramp up before VDD. |



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6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

| | | MIN | MAX | UNIT |
|------------------|--|------|-----------------------|------|
| V _{DD} | Supply voltage, V _{DD} to AGND | -0.3 | 6 | V |
| | Digital inputs to AGND | -0.3 | V _{DD} + 0.3 | V |
| | V _{FBX} to AGND | -0.3 | V _{DD} + 0.3 | V |
| | V _{OUTX} to AGND | -0.3 | V _{DD} + 0.3 | V |
| V _{REF} | External reference, V _{REF} to AGND | -0.3 | V _{DD} + 0.3 | V |
| | Current into any pin except the OUTx, VDD, and AGND pins | -10 | 10 | mA |
| TJ | Junction temperature | -40 | 150 | °C |
| T _{stg} | Storage temperature | -65 | 150 | °C |

(1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

6.2 ESD Ratings

| | | | VALUE | UNIT | |
|--------|---------------|---|-------|------|--|
| V | Electrostatic | Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾ | ±2000 | V | |
| V(ESD) | discharge | Charged device model (CDM), per ANSI/ESDA/JEDEC JS-002, all pins ⁽⁽²⁾⁾ | ±500 | v | |

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

| | | MIN | NOM MAX | UNIT |
|------------------|--|------|-----------------|------|
| V _{DD} | Positive supply voltage to ground (AGND) | 1.7 | 5.5 | V |
| V _{REF} | External reference to ground (AGND) | 1.7 | V _{DD} | V |
| V _{IH} | Digital input high voltage, 1.7 V < $V_{DD} \le 5.5$ V | 1.62 | | V |
| V _{IL} | Digital input low voltage | | 0.4 | V |
| C _{CAP} | External capacitor on CAP pin | 0.5 | 15 | μF |
| T _A | Ambient temperature | -40 | 125 | °C |

6.4 Thermal Information

| | | DACx3004W | |
|-----------------------|--|-------------|------|
| | THERMAL METRIC ⁽¹⁾ | YBH (DSBGA) | UNIT |
| | | 16 PINS | |
| R _{θJA} | Junction-to-ambient thermal resistance | 81.2 | °C/W |
| R _{0JC(top)} | Junction-to-case (top) thermal resistance | 0.3 | °C/W |
| R _{θJB} | Junction-to-board thermal resistance | 20.3 | °C/W |
| Ψ _{JT} | Junction-to-top characterization parameter | 0.2 | °C/W |
| Ψ _{JB} | Junction-to-board characterization parameter | 20.3 | °C/W |

(1) For information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.



6.5 Electrical Characteristics: Voltage Output

all minimum/maximum specifications at $T_A = -40^{\circ}$ C to +125°C and typical specifications at $T_A = 25^{\circ}$ C, 1.7 V $\leq V_{DD} \leq 5.5$ V, DAC reference tied to VDD, gain = 1 ×, DAC output pin (OUT) loaded with resistive load ($R_L = 5 \text{ k}\Omega$ to AGND) and capacitive load ($C_L = 200 \text{ pF}$ to AGND), and digital inputs at VDD or AGND (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|------|---|--|-------|---------|----------|---------|
| STAT | IC PERFORMANCE | | | | | |
| | Desclution | DAC63004W | 12 | | | Dite |
| | Resolution | DAC53004W | 10 | | | Bits |
| | Integral poplingerity((1)) | DAC63004W | -5 | | 5 | |
| INL | Integral nonlinearity ⁽⁽¹⁾⁾ | DAC53004W | -1.25 | | 1.25 | LSB |
| DNL | Differential nonlinearity ⁽¹⁾ | | -1 | | 1 | LSB |
| | | Code 0d into DAC, external reference, V_{DD} = 5.5 V | | 6 | 12 | |
| | Zero-code error ⁽⁴⁾ | Code 0d into DAC, internal V _{REF} , gain = 4 ×, V_{DD} = 5.5 V | | 6 | 15 | mV |
| | Zero-code error temperature coefficient ⁽⁴⁾ | | | ±10 | | µV/°C |
| | Offset error ^{(4) (6)} | 1.7 V \leq V _{DD} $<$ 2.7 V, V _{FB} pin shorted to V _{OUT} , DAC code: 32d for 12-bit resolution | -0.75 | 0.3 | 0.75 | %FSR |
| | Cliset endry (2) | $2.7 \text{ V} \le \text{V}_{\text{DD}} \le 5.5 \text{ V}$, V_{FB} pin shorted to V_{OUT} , DAC code: 32d for 12-bit resolution | -0.5 | 0.25 | 0.5 | 70F3K |
| | Offset-error temperature coefficient ⁽⁴⁾ | V_{FB} pin shorted to $V_{\text{OUT}},$ DAC code: 32d for 12-bit resolution, 8d for 10-bit resolution | | ±0.0003 | | %FSR/°C |
| | Gain error ⁽⁴⁾ | Between end-point codes: 32d to 4064d for 12-bit resolution, 8d to 1016d for 10-bit resolution | -0.5 | 0.25 | 0.5 | %FSR |
| | Gain-error temperature coefficient ⁽⁴⁾ | Between end-point codes: 32d to 4064d for 12-bit resolution, 8d to 1016d for 10-bit resolution | | ±0.0008 | | %FSR/°C |
| | Full-scale error ^{(4) (6)} | $1.7 \text{ V} \le \text{V}_{\text{DD}} \le 2.7 \text{ V}$, DAC at full-scale | -1 | | 1 | %FSR |
| | Full-scale error (1) (9) | $2.7 \text{ V} \le \text{V}_{\text{DD}} \le 5.5 \text{ V}$, DAC at full-scale | -0.5 | | 0.5 | %FSK |
| | Full-scale-error temperature coefficient ⁽⁴⁾ | DAC at full-scale | | ±0.0008 | | %FSR/°C |
| ουτι | PUT | | | | | |
| | Output voltage | Reference tied to V _{DD} | 0 | | V_{DD} | V |
| CL | Capacitive load ⁽²⁾ | R _L = infinite, phase margin = 30° | | | 200 | pF |
| J | | Phase margin = 30° | | | 1000 | р |
| | | V_{DD} = 1.7 V, full-scale output shorted to AGND or zero-scale output shorted to V_{DD} | | 15 | | |
| | Short-circuit current | V_{DD} = 2.7 V, full-scale output shorted to AGND or zero-scale output shorted to V_{DD} | | 50 | | mA |
| | | V_{DD} = 5.5 V, full-scale output shorted to AGND or zero-scale output shorted to V_{DD} | | 60 | | |
| | | To V _{DD} (DAC output unloaded, internal reference = 1.21 V), V _{DD} \ge 1.21 V × gain + 0.2 V | 0.2 | | | V |
| | Output-voltage headroom ⁽²⁾ | To V_{DD} and to AGND (DAC output unloaded, external reference at V_{DD} (gain = 1 ×), the V_{REF} pin is not shorted to V_{DD}) | 0.8 | | | |
| | | To V _{DD} and to AGND (I_{LOAD} = 10 mA at V _{DD} = 5.5 V, I_{LOAD} = 3 mA at V _{DD} = 2.7 V, I_{LOAD} = 1 mA at V _{DD} = 1.8 V), external reference at V _{DD} (gain = 1 ×), the V _{REF} pin is not shorted to V _{DD}) | 10 | | | %FSR |
| Zo | V _{FB} dc output impedance ⁽³⁾ | DAC output enabled, internal reference (gain = $1.5 \times$ or $2 \times$) or external reference at V _{DD} (gain = $1 \times$), the V _{REF} pin is not shorted to V _{DD} | 400 | 500 | 600 | kΩ |
| | | DAC output enabled, internal V _{REF} , gain = 3 × or 4 × | 325 | 400 | 485 | |



6.5 Electrical Characteristics: Voltage Output (continued)

all minimum/maximum specifications at $T_A = -40^{\circ}$ C to +125°C and typical specifications at $T_A = 25^{\circ}$ C, 1.7 V $\leq V_{DD} \leq 5.5$ V, DAC reference tied to VDD, gain = 1 ×, DAC output pin (OUT) loaded with resistive load ($R_L = 5 \text{ k}\Omega$ to AGND) and capacitive load ($C_L = 200 \text{ pF}$ to AGND), and digital inputs at VDD or AGND (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-------------------|--|--|-----|------|-----|------------------|
| | Power supply rejection ratio (dc) | Internal V _{REF} , gain = 2 ×, DAC at midscale, V _{DD} = 5 V \pm 10% | | 0.25 | | mV/V |
| DYN | AMIC PERFORMANCE | | | | | |
| • | | 1/4 to 3/4 scale and 3/4 to 1/4 scale settling to 10%FSR, V_{DD} = 5.5 V | | 20 | | |
| t _{sett} | Output voltage settling time | 1/4 to 3/4 scale and 3/4 to 1/4 scale settling to 10%FSR, V_{DD} = 5.5 V, internal V_{REF} , gain = 4 × | | 25 | | μs |
| | Slew rate | V _{DD} = 5.5 V | | 0.3 | | V/µs |
| | Power-on glitch magnitude | At start-up (DAC output disabled) | | 75 | | mV |
| | Power-on glitch magnitude | At start-up (DAC output disabled), R_L = 100 k Ω | | 200 | | mv |
| | Output-enable glitch magnitude | DAC output disabled to enabled (DAC registers at zero scale), R _L = 100 k Ω | | 250 | | mV |
| | Output poice veltage (peak to | f = 0.1 Hz to 10 Hz, DAC at midscale, V_{DD} = 5.5 V | | 50 | | |
| Vn | Output noise voltage (peak to peak) | Internal V _{REF} , gain = 4 ×, f = 0.1 Hz to 10 Hz, DAC at midscale, V _{DD} = 5.5 V | | 90 | | μV _{PP} |
| | | f = 1 kHz, DAC at midscale, V _{DD} = 5.5 V | | 0.35 | | |
| | Output noise density | Internal V _{REF,} gain = 4 ×, f = 1 kHz, DAC at midscale, V _{DD} = 5.5 V | | 0.9 | | µV/√Hz |
| | Power supply rejection ratio (ac) ⁽³⁾ | Internal V _{REF} , gain = 4 ×, 200-mV 50-Hz or 60-Hz sine wave superimposed on power supply voltage, DAC at midscale | | -68 | | dB |
| | Code change glitch impulse | ±1 LSB change around midscale (including feedthrough) | | 10 | | nV-s |
| | Code change glitch impulse magnitude | ±1 LSB change around midscale (including feedthrough) | | 15 | | mV |
| POW | /ER | | | | | |
| I _{DD} | Current flowing into VDD ^{(4) (5)} | Normal operation, DACs at full scale, digital pins static, external reference at V_{DD} but the V_{REF} pin is not shorted to V_{DD} | | 35 | 50 | µA/ch |

(1) Measured with DAC output unloaded. For external reference and internal reference V_{DD} ≥ 1.21 × gain + 0.2 V, between end-point codes: 32d to 4064d for 12-bit resolution, 8d to 1016d for 10-bit resolution.

(2) Specified by design and characterization, not production tested.

(3) Specified with 200-mV headroom with respect to reference value when internal reference is used.

(4) Measured with DAC output unloaded.

(5) The total power consumption is calculated by I_{DD} × (total number of channels powered on) + (sleep-mode current).

(6) When a DAC channel is configured in IOUT mode for long term and then switched to VOUT mode, the VOUT mode can show parametric drift.



6.6 Electrical Characteristics: Current Output

all minimum/maximum specifications at $T_A = -40^{\circ}$ C to +125°C and typical specifications at $T_A = 25^{\circ}$ C, 1.7 V $\leq V_{DD} \leq 5.5$ V, ±250-µA output range, and digital inputs at VDD or AGND (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|----------------|---|--|-----|------|-----|------------------|
| STAT | IC PERFORMANCE | | | | | |
| | Resolution | | 8 | | | Bits |
| NL | Integral nonlinearity | DAC codes between 10d and 255d for current output range of 0 μA to 25 $\mu A,$ DAC codes between 0d and 255d for other ranges | -1 | | 1 | LSB |
| ONL | Differential nonlinearity | DAC codes between 10d and 255d for current output range of 0 μA to 25 $\mu A,$ DAC codes between 0d and 255d for other ranges | -1 | | 1 | LSB |
| | Offset error | DAC output range: 0 µA to 25 µA, DAC at code 10d | | ±1.5 | | %FSR |
| | Offset error | DAC output ranges: 0 μ A to 50 μ A, 0 μ A to 125 μ A, and 0 μ A to 250 μ A; DAC at zero-scale | | 5 | | %FSR |
| | Offset error | all unipolar negative ranges, DAC at zero-scale | | -5 | | %FSR |
| | Offset error | DAC output ranges: ±25 $\mu A,$ ±50 $\mu A,$ ±125 $\mu A,$ and ±250 $\mu A;$ DAC at midscale | | ±1 | | %FSR |
| | Gain error | DAC output range: 0 μA to 25 $\mu A,$ DAC codes between 10d and 255d | | ±1.5 | | %FSR |
| | Gain error | DAC output ranges: 0 μ A to 50 μ A, 0 μ A to 125 μ A, and 0 μ A to 250 μ A; DAC codes between 0d and 255d | | ±1.5 | | %FSR |
| | Gain error | all unipolar negative ranges, DAC codes between 0d and 255d | | ±5 | | %FSR |
| | Gain error | DAC output ranges: $\pm 25 \ \mu$ A, $\pm 50 \ \mu$ A, $\pm 125 \ \mu$ A, and $\pm 250 \ \mu$ A; DAC codes between 0d and 255d | | ±1.3 | | %FSR |
| ουτι | PUT | | | | | |
| | Output compliance voltage ⁽¹⁾ | DAC output range: 0 μA to 25 $\mu A,$ to V_{DD} and to A_{GND} | 200 | | | mV |
| | Output compliance voltage ⁽¹⁾ | DAC output ranges: 0 μA to 50 μA , 0 μA to 125 μA , and 0 μA to 250 μA ; to V_{DD} | 400 | | | mV |
| | Output compliance voltage ⁽¹⁾ | all unipolar negative ranges, to V _{DD} | 400 | | | mv |
| | Output compliance voltage ⁽¹⁾ | DAC output ranges: ±25 $\mu A,$ ±50 $\mu A,$ ±125 $\mu A,$ and ±250 $\mu A;$ to V_{DD} and to AGND | 400 | | | mV |
| z _o | I _{OUT} dc output impedance ⁽²⁾ | DAC at midscale, DAC output kept at $V_{DD}/2$ | 60 | | | MΩ |
| | Power supply rejection ratio (dc) | DAC at midscale, output range: 0 μA to 25 $\mu A,$ V_{DD} changed from 4.5 V to 5.5 V | | 0.28 | | LSB/V |
| | Power supply rejection ratio (dc) | DAC at midscale, all unipolar positive ranges, V_{DD} changed from 4.5 V to 5.5V | | 0.33 | | LSB/V |
| | Power supply rejection ratio (dc) | DAC at midscale, all unipolar negative ranges, V_{DD} changed from 4.5 V to 5.5V | | 0.83 | | LSB/V |
| | Power supply rejection ratio (dc) | DAC at midscale, all bipolar ranges, V_{DD} changed from 4.5V to 5.5V | | 0.23 | | LSB/V |
| DYN/ | AMIC PERFORMANCE | | | | | |
| sett | Output current settling time | 1/4 to 3/4 scale and 3/4 to 1/4 scale settling to 1 LSB at 8-bit resolution, V_{DD} = 5.5 V, common-mode voltage at OUTx pin is $V_{DD}/2$ | | 60 | | μs |
| / _n | Output noise current (peak to peak) | 0.1 Hz to 10 Hz, DAC at midscale, V _{DD} = 5.5 V, \pm 250-µA output range | | 150 | | nA _{PP} |
| | Output noise density | f = 1 kHz, DAC at midscale, V _{DD} = 5.5 V, \pm 250- μ A output range | | 1 | | nA/√Hz |
| | Power supply rejection ratio (ac) ⁽³⁾ | ±250 μA output range, 200-mV 50-Hz or 60-Hz sine wave superimposed on power-supply voltage, DAC at midscale | | 0.65 | | LSB/V |

6.6 Electrical Characteristics: Current Output (continued)

all minimum/maximum specifications at $T_A = -40^{\circ}$ C to +125°C and typical specifications at $T_A = 25^{\circ}$ C, 1.7 V $\leq V_{DD} \leq 5.5$ V, ±250-µA output range, and digital inputs at VDD or AGND (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-----------------|---|---|-----|-----|-----|---------|
| POW | /ER | | | | | |
| I _{DD} | Current flowing into VDD ^{(3) (4)} | Normal operation, DACs at midscale, all unipolar output ranges, digital pins static | | 18 | 24 | µA/ch |
| | | Normal operation, DACs at full scale, ±25-µA output range, digital pins static | · | 42 | 50 | |
| | Current flowing into VDD ^{(3) (4)} | Normal operation, DACs at full scale, ±50-µA output range, digital pins static | | 56 | 70 | u A /ab |
| IDD | | Normal operation, DACs at full scale, ±125-µA output range, digital pins static | | 98 | 120 | µA/ch |
| | | Normal operation, DACs at full scale, ±250-µA output range, digital pins static | | 167 | 200 | |

(1) Measured between DAC codes 0d and 255d.

(2) Specified by design and characterization, not production tested.

(3) The current flowing into V_{DD} does not account for the load current sourced or sunk on the OUTx pins. The V_{REF} pin is connected to V_{DD} .

(4) The total power consumption is calculated by I_{DD} × (total number of channels powered on) + (sleep-mode current).



6.7 Electrical Characteristics: Comparator Mode

all minimum/maximum specifications at $T_A = -40^{\circ}$ C to +125°C and typical specifications at $T_A = 25^{\circ}$ C, 1.7 V \leq V_{DD} \leq 5.5 V, DAC reference tied to VDD, gain = 1 × in voltage output mode, DAC output pin (OUT) loaded with resistive load (R_L = 5 k Ω to AGND) and capacitive load (C_L = 200 pF to AGND), and digital inputs at VDD or AGND (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-------------------|--|--|-----|-----|---------------------------------|------|
| STAT | TIC PERFORMANCE | | | | | |
| | Offset error ^{(1) (2)} | 1.7 V \leq V _{DD} \leq 5.5 V; DAC at midscale, comparator input at Hi-Z, and DAC operating with external reference. | -6 | 0 | 6 | mV |
| | Offset error time drift ⁽¹⁾ | V_{DD} = 5.5 V, external reference, T_A = 125°C, FB in Hi-Z mode, DAC at full scale and V_{FB} at 0 V or DAC at zero scale and V_{FB} at 1.84 V, drift specified for 10 years of continuous operation | | 4 | | mV |
| OUT | PUT | | | | | |
| | | V _{REF} connected to V _{DD} , V _{FB} resistor network connected to ground | 0 | | V _{DD} | V |
| | Input voltage | V _{REF} connected to V _{DD} , V _{FB} resistor network disconnected from ground | 0 | | V _{DD} × (1/3 – 1/100) | |
| V _{OL} | Logic low output voltage | I_{LOAD} = 100 µA, output in open-drain mode | | 0.1 | | V |
| DYN | AMIC PERFORMANCE | | | | | |
| t _{resp} | Output response time | DAC at midscale with 10-bit resolution, FB input at Hi-Z, and transition step at FB node is $(V_{DAC} - 2 LSB)$ to $(V_{DAC} + 2 LSB)$, transition time measured between 10% and 90% of output, output current of 100 µA, comparator output configured in push-pull mode, load capacitor at DAC output is 25 pF | | 10 | | μs |

(1) Specified by design and characterization, not production tested.

(2) This specification does not include the total unadjusted error (TUE) of the DAC.

6.8 Electrical Characteristics: General

all minimum/maximum specifications at $T_A = -40^{\circ}$ C to +125°C and typical specifications at $T_A = 25^{\circ}$ C, 1.7 V $\leq V_{DD} \leq 5.5$ V, DAC reference tied to VDD, gain = 1 × in voltage output mode or ±250-µA output range in current output mode, DAC output pin (OUT) loaded with resistive load ($R_L = 5 \text{ k}\Omega$ to AGND) in voltage-output mode and capacitive load ($C_L = 200 \text{ pF}$ to AGND), and digital inputs at VDD or AGND (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT | |
|-------|--|--|--------|------------|-------|--------|--|
| INTE | RNAL REFERENCE | 1 | | | | | |
| | Initial accuracy | T _A = 25°C | 1.1979 | 1.212 | 1.224 | V | |
| | Reference output temperature coefficient ⁽¹⁾ ⁽²⁾ | | | | 50 | ppm/°C | |
| EXTE | ERNAL REFERENCE | | | | | | |
| | V _{REF} input impedance ^{(1) (3)} | | | 192 | | kΩ-ch | |
| EEPF | ROM | | | | | | |
| | Endurance ⁽¹⁾ | $-40^{\circ}C \le T_{A} \le +85^{\circ}C$ | | 20000 | | Cualaa | |
| | | T _A = 125°C | | 1000 50 | | Cycles | |
| | Data retention ⁽¹⁾ | T _A = 25°C | | 50 | | Years | |
| | EEPROM programming write cycle time ⁽¹⁾ | | · | | 200 | ms | |
| | Device boot-up time ⁽¹⁾ | Time taken from power valid ($V_{DD} \ge 1.7 \text{ V}$) to output valid state (output state as programmed in EEPROM), 0.5-µF capacitor on the CAP pin | | 5 | | ms | |
| DIGIT | TAL INPUTS | · · · · · · | | | | | |
| | Digital feedthrough | Voltage output mode, DAC output static at midscale, fast mode plus, SCL toggling | | 20 | | nV-s | |
| | Pin capacitance | Per pin | | 10 | | pF | |
| POW | ER-DOWN MODE | · · · · · | | | | | |
| DD | Current flowing into VDD | DAC in deep-sleep mode, internal reference powered down, SDO mode disabled | | 1.5 | 3 | μA | |
| DD | Current flowing into VDD | DAC in sleep mode, internal reference powered down, external reference at 5.5 V | · | | 28 | μA | |
| DD | Current flowing into VDD ⁽¹⁾ | DAC in sleep mode, internal reference enabled, additional current through internal reference | | 10 | | μA | |
| DD | Current flowing into VDD ⁽¹⁾ | DAC channels enabled, internal reference enabled, additional current through internal reference per DAC channel in voltage-output mode | | 12.5 | | μA | |
| HIGH | I-IMPEDANCE OUTPUT | | | | | | |
| | | DAC in Hi-Z output mode, $1.7 \text{ V} \le \text{V}_{\text{DD}} \le 5.5 \text{ V}$ | | 10 | | nA | |
| | Current flowing into V | V_{DD} = 0 V, V_{OUT} \leq 1.5 V, decoupling capacitor between V_{DD} and AGND = 0.1 μF | | 200 | | nA | |
| LEAK | Current flowing into V_{OUTX} and V_{FBX} | V_{DD} = 0 V, 1.5 V < V_{OUT} ≤ 5.5 V, decoupling capacitor between V_{DD} and AGND = 0.1 μF | | 500 | | nA | |
| | | 100 kΩ between V _{DD} and AGND, V _{OUT} ≤ 1.25 V, series resistance of 10 kΩ at OUT pin | | ±2 | | μA | |

(1) Specified by design and characterization, not production tested.

(2) Measured at -40° C and $+125^{\circ}$ C and calculated the slope.

(3) Impedances for the DAC channels are connected in parallel.



6.9 Timing Requirements: I²C Standard Mode

all input signals are timed from VIL to 70% of $V_{pull-up}$, 1.7 V $\leq V_{DD} \leq 5.5$ V, $-40^{\circ}C \leq T_A \leq +125^{\circ}C$, and 1.7 V $\leq V_{pull-up} \leq V_{DD}$ V

| ! | | <u></u> | , pui | up DD |
|--------------------|--|---------|---------|-------|
| | | MIN | NOM MAX | UNIT |
| f _{SCL} | SCL frequency | | 100 | kHz |
| t _{BUF} | Bus free time between stop and start conditions | 4.7 | | μs |
| t _{HDSTA} | Hold time after repeated start | 4 | | μs |
| t _{SUSTA} | Repeated start setup time | 4.7 | | μs |
| t _{SUSTO} | Stop condition setup time | 4 | | μs |
| t _{HDDAT} | Data hold time | 0 | | ns |
| t _{SUDAT} | Data setup time | 250 | | ns |
| t _{LOW} | SCL clock low period | 4700 | | ns |
| t _{HIGH} | SCL clock high period | 4000 | | ns |
| t _F | Clock and data fall time | | 300 | ns |
| t _R | Clock and data rise time | | 1000 | ns |
| t _{VDDAT} | Data valid time, R = 360 Ω , C _{trace} = 23 pF, C _{probe} = 10 pF | | 3.45 | μs |
| t _{VDACK} | Data valid acknowledge time, R = 360 Ω , C _{trace} = 23 pF, C _{probe} = 10 pF | | 3.45 | μs |

6.10 Timing Requirements: I²C Fast Mode

all input signals are timed from VIL to 70% of $V_{pull-up}$, 1.7 V $\leq V_{DD} \leq 5.5$ V, $-40^{\circ}C \leq T_A \leq +125^{\circ}C$, and 1.7 V $\leq V_{pull-up} \leq V_{DD}$ V MIN NOM MAX UNIT f_{SCL} SCL frequency 400 kHz Bus free time between stop and start conditions 1.3 t_{BUF} μs t_{HDSTA} Hold time after repeated start 0.6 μs 0.6 Repeated start setup time t_{SUSTA} μs 0.6 Stop condition setup time t_{SUSTO} μs t_{HDDAT} Data hold time 0 ns Data setup time 100 ns t_{SUDAT} t_{LOW} SCL clock low period 1300 ns SCL clock high period 600 t_{HIGH} ns Clock and data fall time 300 t_F ns Clock and data rise time 300 t_R ns Data valid time, R = 360 Ω, C_{trace} = 23 pF, C_{probe} = 10 pF 0.9 μs t_{VDDAT} Data valid acknowledge time, R = 360 Ω , C_{trace} = 23 pF, C_{probe} = 10 pF 0.9 t_{VDACK} μs

6.11 Timing Requirements: I²C Fast Mode Plus

all input signals are timed from VIL to 70% of $V_{pull-up}$, 1.7 V $\leq V_{DD} \leq 5.5$ V, $-40^{\circ}C \leq T_A \leq +125^{\circ}C$, and 1.7 V $\leq V_{pull-up} \leq V_{DD}$ V

| | e pair ap | | san | , ap 22 |
|--------------------|--|------|---------|---------|
| | | MIN | NOM MAX | UNIT |
| f _{SCL} | SCL frequency | | 1 | MHz |
| t _{BUF} | Bus free time between stop and start conditions | 0.5 | | μs |
| t _{HDSTA} | Hold time after repeated start | 0.26 | | μs |
| t _{SUSTA} | Repeated start setup time | 0.26 | | μs |
| t _{susto} | Stop condition setup time | 0.26 | | μs |
| t _{HDDAT} | Data hold time | 0 | | ns |
| t _{SUDAT} | Data setup time | 50 | | ns |
| t _{LOW} | SCL clock low period | 0.5 | | μs |
| t _{HIGH} | SCL clock high period | 0.26 | | μs |
| t _F | Clock and data fall time | | 120 | ns |
| t _R | Clock and data rise time | | 120 | ns |
| t _{VDDAT} | Data valid time, R = 360 Ω , C _{trace} = 23 pF, C _{probe} = 10 pF | | 0.45 | μs |
| t _{VDACK} | Data valid acknowledge time, R = 360 Ω, C _{trace} = 23 pF, C _{probe} = 10 pF | | 0.45 | μs |



6.12 Timing Requirements: SPI Write Operation

all input signals are specified with $t_r = t_f = 1$ V/ns (10% to 90% of V_{IO}) and timed from a voltage level of (VIL + VIH) / 2, 1.7 V \leq V_{IO} \leq 5.5 V, 1.7 V \leq V_{DD} \leq 5.5 V, and $-40^{\circ}C \leq T_A \leq +125^{\circ}C$

| | | MIN | NOM | MAX | UNIT |
|------------------------|---|-----|-----|-----|------|
| f _{SCLK} | Serial clock frequency | | | 50 | MHz |
| t _{SCLKHIGH} | SCLK high time | 9 | | | ns |
| t _{SCLKLOW} | SCLK low time | 9 | | | ns |
| t _{SDIS} | SDI setup time | 8 | | | ns |
| t _{SDIH} | SDI hold time | 8 | | | ns |
| t _{CSS} | CS to SCLK falling edge setup time | 18 | | | ns |
| t _{CSH} | SCLK falling edge to CS rising edge | 10 | | | ns |
| t _{CSHIGH} | CS high time | 50 | | | ns |
| t _{DACWAIT} | Sequential DAC update wait time (time between subsequent LDAC falling edges) for same channel | 2 | | | μs |
| t _{BCASTWAIT} | Broadcast DAC update wait time (time between subsequent LDAC falling edges) | 2 | | | μs |

6.13 Timing Requirements: SPI Read and Daisy Chain Operation (FSDO = 0)

all input signals are specified with $t_r = t_f = 1$ V/ns (10% to 90% of V_{IO}) and timed from a voltage level of (VIL + VIH) / 2, 1.7 V \leq V_{IO} \leq 5.5 V, 1.7 V \leq V_{DD} \leq 5.5 V, -40°C \leq T_A \leq +125°C, and FSDO = 0

| | | MIN | NOM MAX | UNIT |
|-----------------------|---|-----|---------|------|
| f _{SCLK} | Serial clock frequency | | 1.25 | MHz |
| t _{SCLKHIGH} | SCLK high time | 350 | | ns |
| t _{SCLKLOW} | SCLK low time | 350 | | ns |
| t _{SDIS} | SDI setup time | 8 | | ns |
| t _{SDIH} | SDI hold time | 8 | | ns |
| t _{CSS} | SYNC to SCLK falling edge setup time | 400 | | ns |
| t _{CSH} | SCLK falling edge to SYNC rising edge | 400 | | ns |
| t _{CSHIGH} | SYNC high time | 1 | | μs |
| t _{SDODLY} | SCLK rising edge to SDO falling edge, $I_{OL} \le 5$ mA, $C_L = 20$ pF. | | 300 | ns |

6.14 Timing Requirements: SPI Read and Daisy Chain Operation (FSDO = 1)

all input signals are specified with $t_r = t_f = 1$ V/ns (10% to 90% of V_{IO}) and timed from a voltage level of (VIL + VIH) / 2, 1.7 V $\leq V_{IO} \leq 5.5$ V, 1.7 V $\leq V_{DD} \leq 5.5$ V, $-40^{\circ}C \leq T_A \leq +125^{\circ}C$, and FSDO = 1

| | | MIN | NOM M | ٩X | UNIT |
|-----------------------|---|-----|-------|-----|------|
| f _{SCLK} | Serial clock frequency | | : | 2.5 | MHz |
| t _{SCLKHIGH} | SCLK high time | 175 | | | ns |
| t _{SCLKLOW} | SCLK low time | 175 | | | ns |
| t _{SDIS} | SDI setup time | 8 | | | ns |
| t _{SDIH} | SDI hold time | 8 | | | ns |
| t _{CSS} | SYNC to SCLK falling edge setup time | 300 | | | ns |
| t _{CSH} | SCLK falling edge to SYNC rising edge | 300 | | | ns |
| t _{CSHIGH} | SYNC high time | 1 | | | μs |
| t _{SDODLY} | SCLK rising edge to SDO falling edge, $I_{OL} \le 5$ mA, $C_L = 20$ pF. | | 3 | 00 | ns |

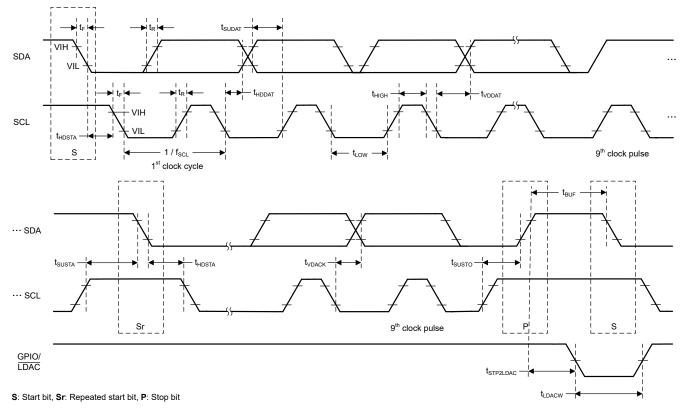


6.15 Timing Requirements: GPIO

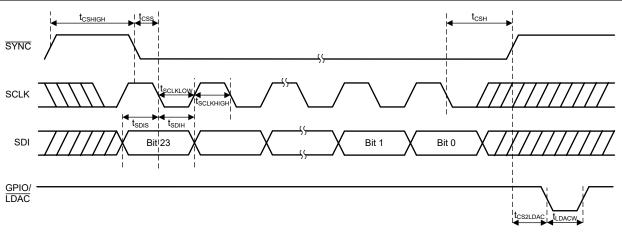
all input signals are specified with $t_r = t_f = 1$ V/ns (10% to 90% of V_{IO}) and timed from a voltage level of (VIL + VIH) / 2, 1.7 V \leq V_{IO} \leq 5.5 V, 1.7 V \leq V_{DD} \leq 5.5 V, and -40° C \leq T_A \leq +125°C

| | | MIN | NOM | MAX | UNIT |
|-----------------------|--|-----|-----|-----|------|
| t _{GPIHIGH} | GPI high time | 2 | | | μs |
| t _{GPILOW} | GPI low time | 2 | | | μs |
| t _{GPAWGD} | LDAC falling edge to DAC update delay | | | 2 | μs |
| t _{CS2LDAC} | SYNC rising edge to LDAC falling edge | 1 | | | μs |
| t _{STP2LDAC} | I ² C stop bit rising edge to LDAC falling edge | 1 | | | μs |
| t _{LDACW} | LDAC low time | 2 | | | μs |

6.16 Timing Diagrams









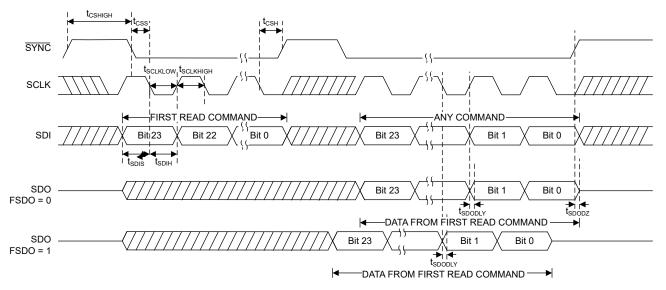
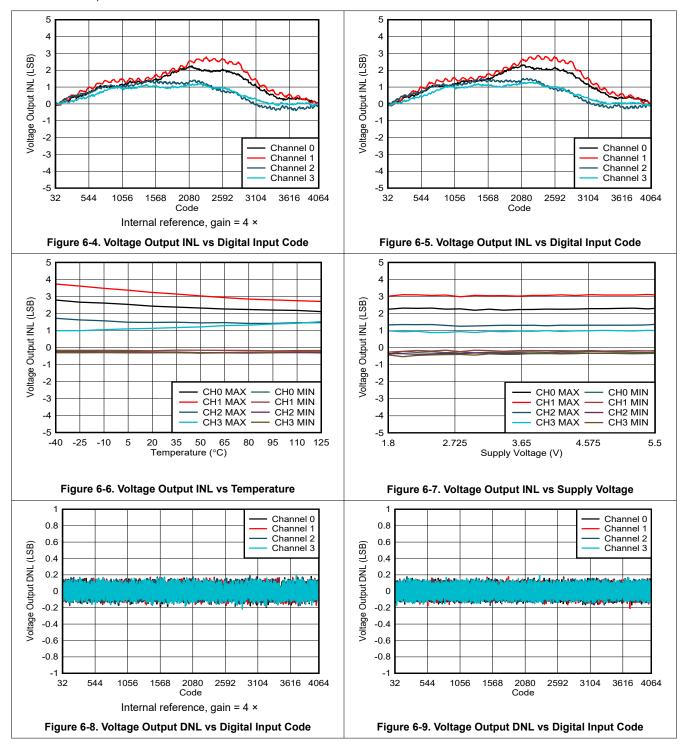


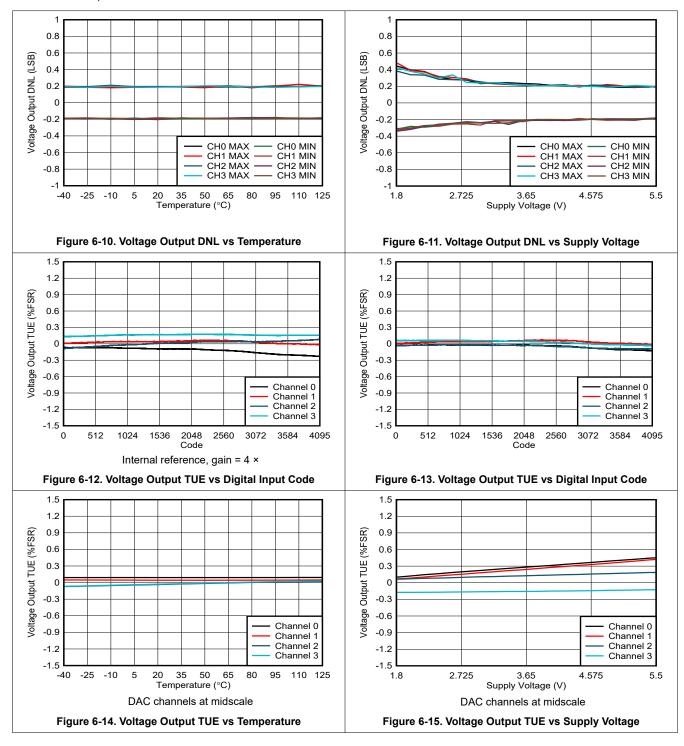
Figure 6-3. SPI Read Timing Diagram



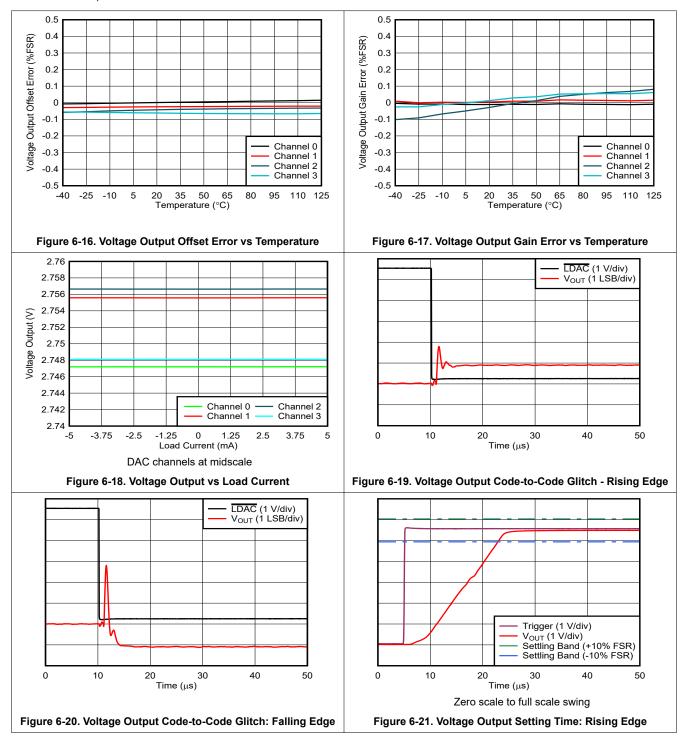
6.17 Typical Characteristics: Voltage Output



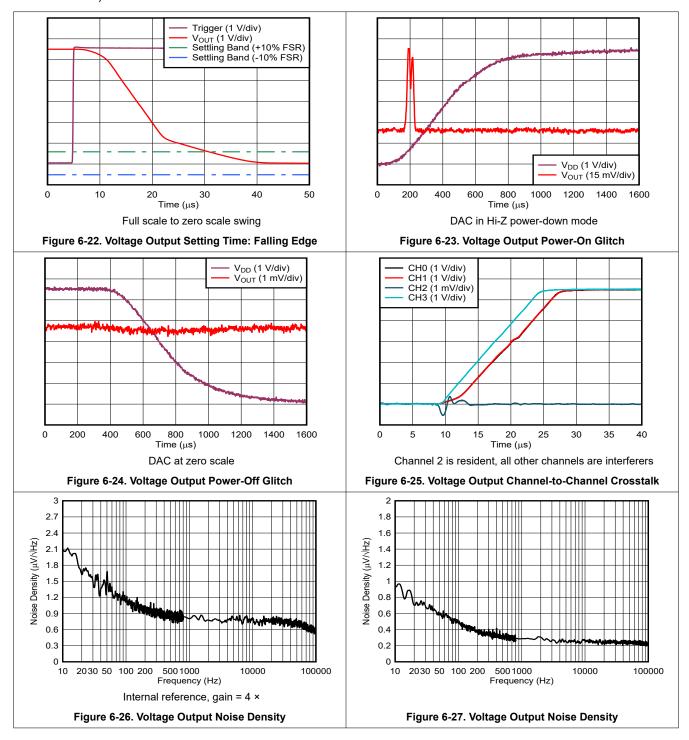




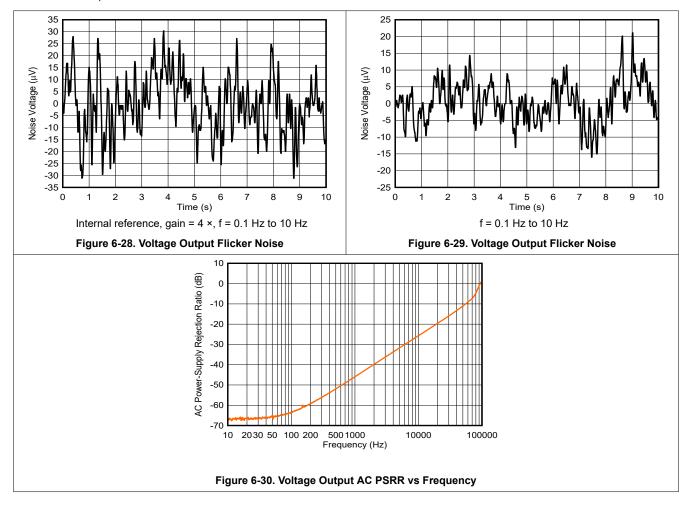






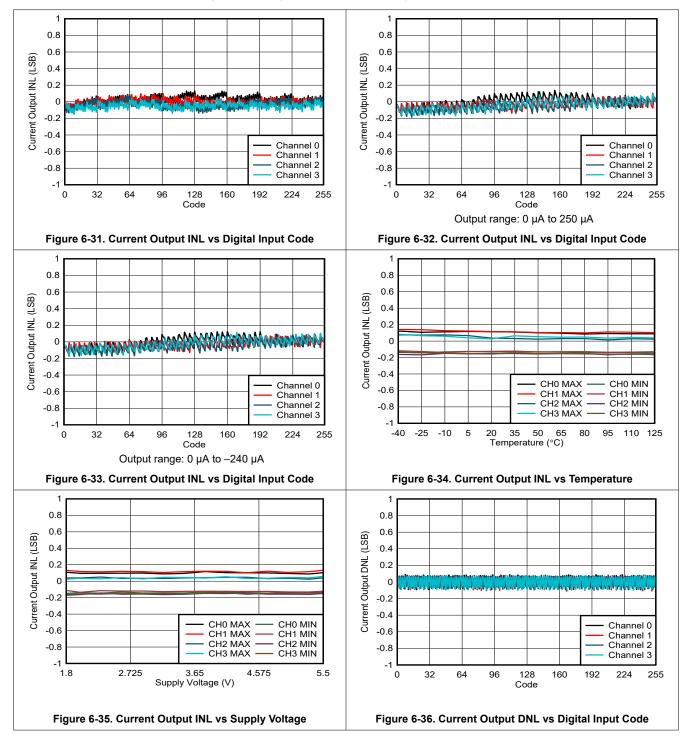




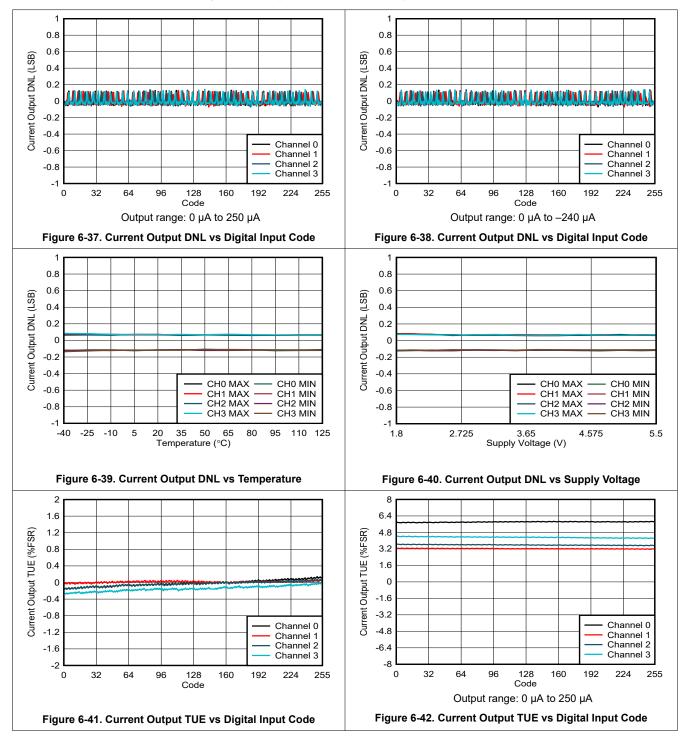


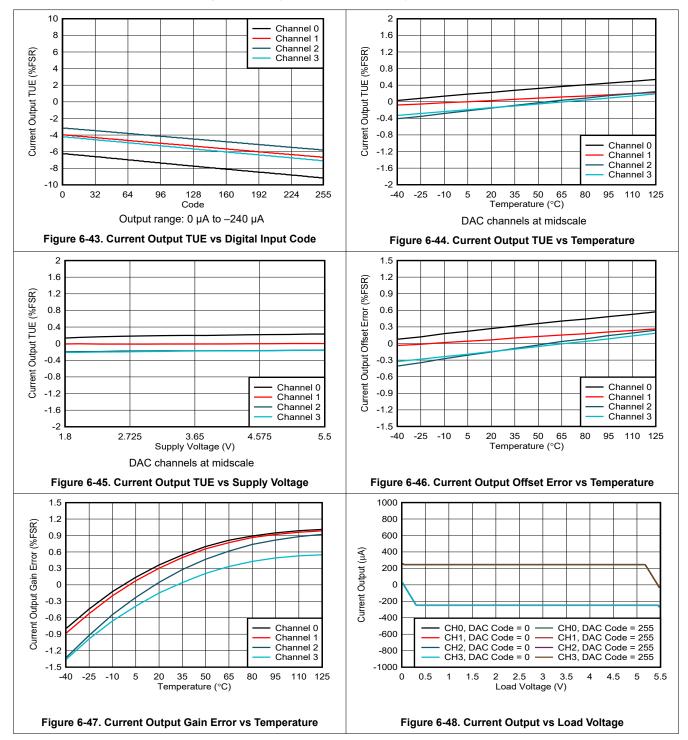


6.18 Typical Characteristics: Current Output

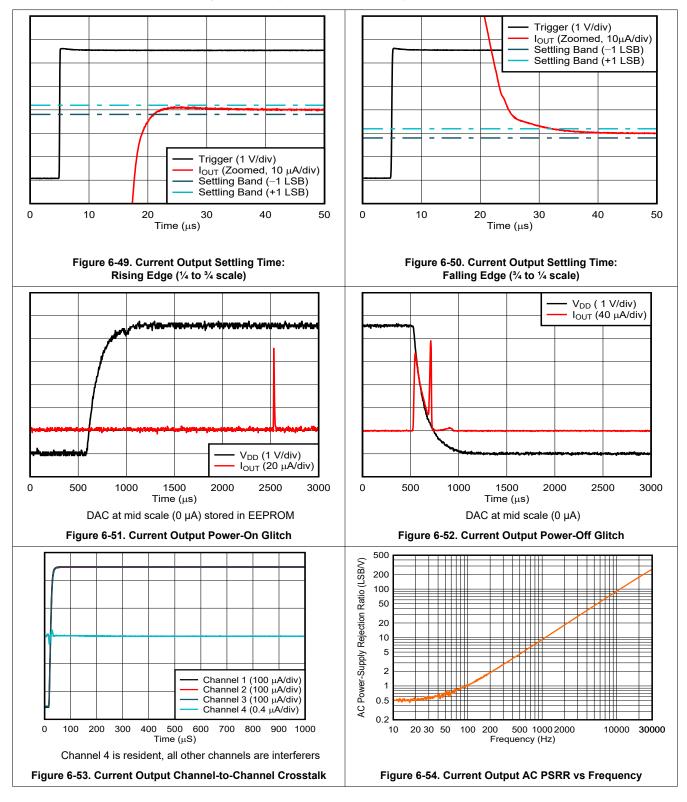


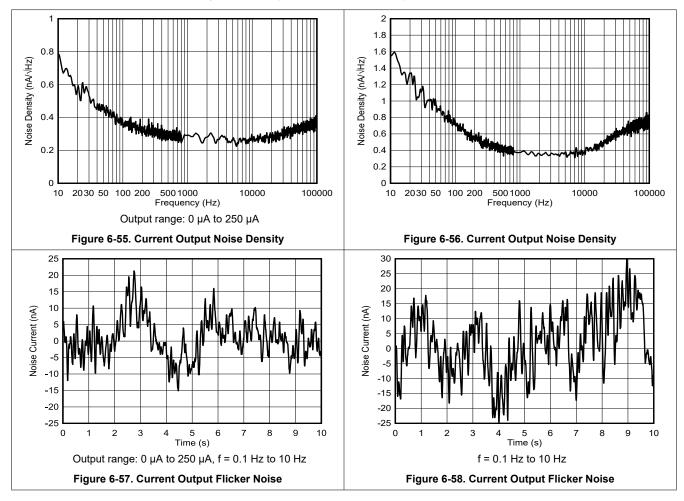






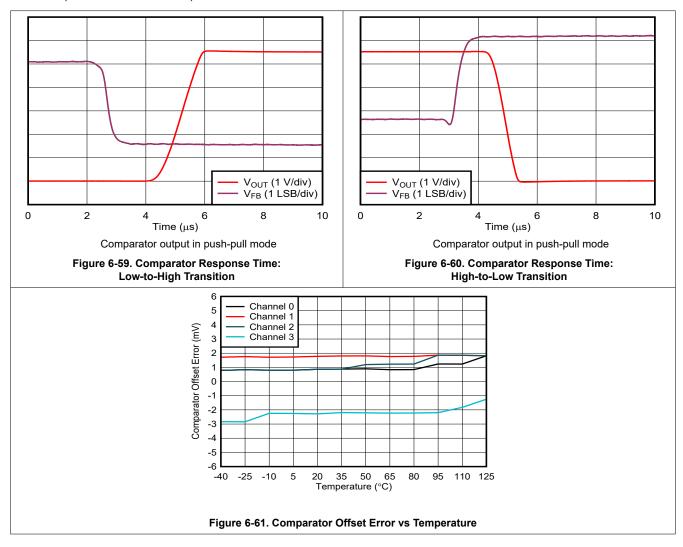








6.19 Typical Characteristics: Comparator

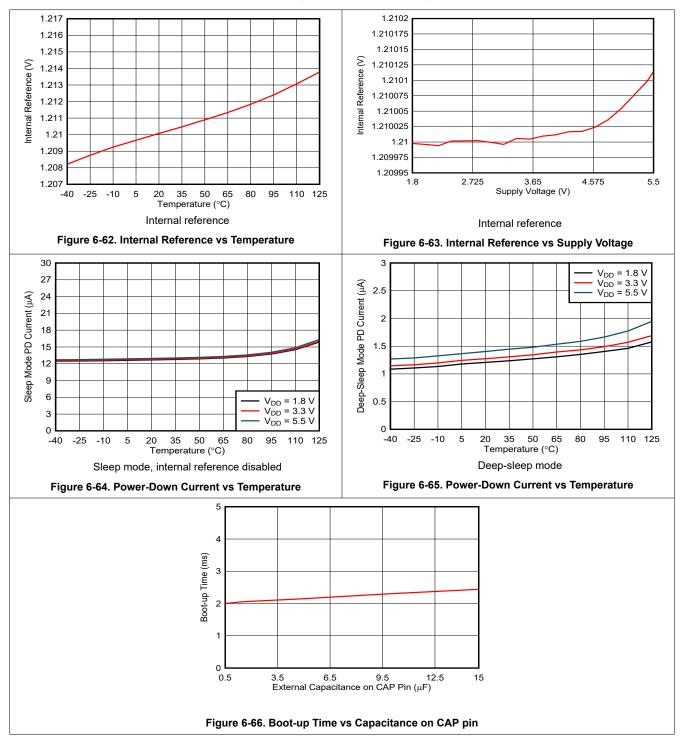


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6.20 Typical Characteristics: General

at T_A = 25°C, V_{DD} = 5.5 V, and DAC outputs unloaded (unless otherwise noted)





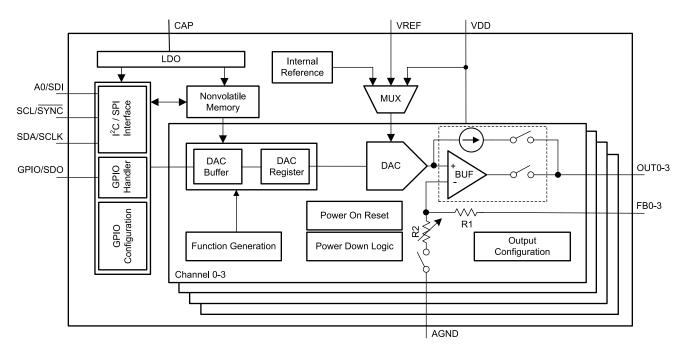
7 Detailed Description

7.1 Overview

The 12-bit DAC63004W and 10-bit DAC53004W (DACx3004W) are a pin-compatible family of quad-channel, buffered, voltage-output and current-output, smart digital-to-analog converters (DACs). The DAC channels are independently configurable as voltage or current output. The DAC outputs change to Hi-Z when VDD is off. This feature is useful in voltage-margining applications. These smart DACs contain nonvolatile memory (NVM), an internal reference, automatically detectable SPI or I²C interface, PMBus-compatibility in I²C mode, force-sense output, and a general-purpose input. These devices support Hi-Z power-down modes by default, which can be configured to 10 k Ω -GND or 100 k Ω -GND using the NVM. The DACx3004W have a power-on-reset (POR) circuit that makes sure all the registers start with default or user-programmed settings using NVM. The DACx3004W operate with either an internal reference, external reference, or with a power supply as the reference, and provide a full-scale output of 1.8 V to 5.5 V.

The DACx3004W devices support I²C standard mode (100Kbps), fast mode (400Kbps), and fast mode plus (1Mbps). The I²C interface can be configured with four target addresses using the A0 pin. These devices also support specific PMBus commands such as *turn on/off, margin high or low*, and more. The SPI mode supports a three-wire interface by default with up to a 50-MHz SCLK input. The GPIO input can be configured as SDO in the NVM for SPI read capability. The GPIO input can alternatively be configured as the LDAC, PD, STATUS, FAULT-DUMP, RESET, or PROTECT function.

The DACx3004W also include digital slew rate control, and support standard waveform generation such as *sine and cosine, triangular*, and *sawtooth* waveforms. These devices can generate pulse-width modulation (PWM) output with the combination of the triangular or sawtooth waveform and the FB pin. The force-sense outputs of the DAC channels can be used as programmable comparators. The comparator mode allows programmable hysteresis, latching comparator, window comparator, and fault-dump to the NVM. These features enable the DACx3004W to go beyond the limitations of a conventional DAC that depends on a processor to function. As a result of *processor-less* operation and the *smart* feature set, the DACx3004W are called smart DACs.



7.2 Functional Block Diagram

Figure 7-1. Functional Block Diagram



7.3 Feature Description

7.3.1 Smart Digital-to-Analog Converter (DAC) Architecture

The DACx3004W devices consist of string architecture with a voltage-output amplifier and an external FB pin and voltage-to-current converter for each channel. Section 7.2 shows the DAC architecture within the block diagram, which operates from a 1.8-V to 5.5-V power supply. The DAC has an internal voltage reference of 1.21 V. There is an option to select an external reference on the VREF pin or the power supply as a reference. The voltage output mode uses one of these three reference options. The current output mode uses an internal band gap to generate the current outputs. Both the voltage- and current-output modes support multiple programmable output ranges.

The DACx3004W devices support Hi-Z output when VDD is off, maintaining very low leakage current at the output pins with up to 1.25 V of forced voltage. The DAC output pin also starts up in high-impedance mode by default, making these devices an excellent choice for voltage margining and scaling applications. To change the power-up mode to 10 k Ω -GND or 100 k Ω -GND, program the corresponding VOUT-PDN-X field in the COMMON-CONFIG register and load these bits in the device NVM.

The DACx3004W devices support an independent comparator mode for each channel. The respective FBx pins act as the inputs for the comparator. The DAC architecture supports inversion of the comparator output using register settings. The comparator outputs can be push-pull or open-drain. The comparator mode supports programmable hysteresis using *margin-high* and *margin-low* register fields, latching comparator, and window comparator. The comparator outputs are accessible internally by the device.

The DACx3004W devices include a *smart* feature set to enable processor-less operation and high-integration. The NVM enables a predictable start-up. The GPIO triggers the DAC output without the I²C interface in the absence of a processor or when the processor or software fails. The integrated functions and the FBx pin enable PWM output for control applications. The FBx pin enables this device to be used as a programmable comparator. The digital slew-rate control and the Hi-Z power-down modes enable a hassle-free voltage margining and scaling function.

7.3.2 Digital Input/Output

The DACx3004W have four digital IO pins that include I²C, SPI, PMBus, and GPIO interfaces. These devices automatically detect I²C and SPI protocols at the first successful communication after power-on, and then connect to the detected interface. After an interface protocol is connected, any change in the protocol is ignored. The I²C interface uses the A0 pin to select from among four address options. The SPI interface is a 3-wire interface by default. No readback capability is available in this mode. The GPIO pin can be configured in the register map and then programmed in to the NVM as the SDO pin. The SPI readback mode is slower than the write mode. The programming interface pins are:

- I²C: SCL, SDA, A0
- SPI: SCLK, SDI, <u>SYNC</u>, SDO/GPIO

The GPIO can be configured as multiple functions other than SDO. These are LDAC, PD, STATUS, PROTECT, FAULT-DUMP, and RESET. All the digital pins are open-drain when used as outputs. Therefore, all the output pins must be pulled up to the desired IO voltage using external resistors.



7.3.3 Nonvolatile Memory (NVM)

The DACx3004W contain nonvolatile memory (NVM) bits. These memory bits are user programmable and erasable, and retain the set values in the absence of a power supply. All the register bits, as shown in the highlighted gray cells in the *Register Map* section, can be stored in the NVM by setting NVM-PROG = 1 in the COMMON-TRIGGER register. The NVM-PROG is an autoresetting bit. The default values for all the registers in the DACx3004W are loaded from NVM as soon as a POR event is issued.

The DACx3004W also implement NVM-RELOAD bit in the COMMON-TRIGGER register. Set this bit to 1 for the device to start an NVM-reload operation. After completion, the device autoresets the NVM-RELOAD bit to 0. During the NVM write or reload operation, all read/write operations to the device are blocked. The *Electrical Characteristics: General* section provides the timing specification for the NVM write cycle. The processor must wait for the specified duration before resuming any read or write operation on the SPI or I²C interface.

7.3.4 Power Consumption

The power consumption of the DACx3004W in sleep mode and deep-sleep mode are provided in the *Typical Characteristics: General* section. In normal operation, the total power consumption of the device depends on the number of channels powered on and the output mode of each channel (voltage or current). In current-output mode, the I_{DD} also depends on the output range. The I_{DD} calculation excludes the load current. For example, in the ±250 µA output mode with a DAC setting of +125 µA, the total current drawn through the VDD pin is the total I_{DD} plus 125 µA. The total I_{DD} in normal operation can be calculated using Equation 1.

$$P_{\text{NORMAL}_MODE} = V_{\text{DD}} \times (I_{\text{DD}_S\text{LEEP}} + I_{\text{DD}_R\text{EF}}) + \sum_{X}^{3} = 0 (V_{\text{DD}} \times I_{\text{DD}_X})$$
(1)

where:

- I_{DD_SLEEP} is the current through V_{DD} in sleep mode when all the channels and internal reference are powered down.
- I_{DD REF} is the reference current, which is:
 - either the current drawn by the reference input impedance when V_{DD} is used as reference
 - or the current drawn by the internal reference, if enabled
- I_{DD X} is the current through V_{DD} for every powered-on channel-X.

Note

When an external reference is used, the current is calculated mainly as the current sourced from the external reference, which is equal to the reference voltage divided by the input impedance of the VREF pin.



7.4 Device Functional Modes

7.4.1 Voltage-Output Mode

The voltage-output mode for each DAC channel can be entered by selecting the power-up option in the VOUT-PDN-X fields in the COMMON-CONFIG register and simultaneously powering down the current output option for the respective channels using the IOUT-PDN-X bits in the same register. Short the OUTx and FBx pins of respective channels externally for closed-loop amplifier output. An open FBx pin saturates the amplifier output. To achieve the desired voltage output, select the correct reference option, select the amplifier gain for the required output range, and program the DAC code in the DAC-X-DATA register of the respective channels.

7.4.1.1 Voltage Reference and DAC Transfer Function

There are three voltage reference options possible with the DACx3004W: internal reference, external reference, and the power supply as reference, as shown in Figure 7-2. The DAC transfer function in the voltage-output and comparator modes changes based on the voltage reference selection.

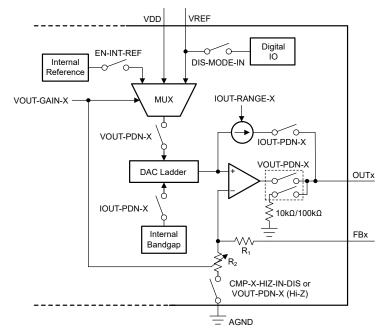


Figure 7-2. Voltage Reference Selection and Power-Down Logic

7.4.1.1.1 Internal Reference

The DACx3004W contain an internal reference that is disabled by default. To enable the internal reference, write 1 to bit EN-INT-REF in the COMMON-CONFIG register. The internal reference generates a fixed 1.21-V voltage (typical). Use the VOUT-GAIN-X bit in the DAC-X-VOUT-CMP-CONFIG register to achieve gains of 1.5 ×, 2 ×, 3 ×, or 4 × for the DAC output voltage (V_{OUT}). Equation 2 shows DAC transfer function using the internal reference.

$$V_{OUT} = \frac{DAC_DATA}{2^N} \times V_{REF} \times GAIN$$

(2)

where:

- N is the resolution in bits, 10 (DAC53004W) or 12 (DAC63004W).
- DAC_DATA is the decimal equivalent of the binary code that is loaded to the DAC-X-DATA bit in the DAC-X-DATA register. DAC_DATA ranges from 0 to 2^N – 1.
- V_{REF} is the internal reference voltage = 1.21 V (typical).
- GAIN = 1.5 ×, 2 ×, 3 ×, or 4 ×, based on VOUT-GAIN-X bits.



(3)

(4)

7.4.1.1.2 External Reference

By default, the DACx3004W operate from an external reference input. The external reference option can also be selected by configuring the VOUT-GAIN-X field in the DAC-X-VOUT-CMP-CONFIG register appropriately. Write 1 to the DIS-MODE-IN bit in the DEVICE-MODE-CONFIG register to minimize I_{DD} . The external reference can be between 1.7 V and VDD. Equation 3 shows DAC transfer function when the external reference is used. The gain at the output stage of the DAC is always 1 × in the external reference mode.

Note

The external reference must be less than VDD in both transient and steady-state conditions. Therefore, the external reference must ramp up after VDD and ramp down before VDD.

$$V_{OUT} = \frac{DAC_DATA}{2^N} \times V_{REF}$$

where:

- N is the resolution in bits, 10 (DAC53004W) or 12 (DAC63004W).
- DAC_DATA is the decimal equivalent of the binary code that is loaded to the DAC-X-DATA field in the DAC-X-DATA register. DAC_DATA ranges from 0 to 2^N – 1.
- V_{REF} is the external reference voltage.

7.4.1.1.3 Power-Supply as Reference

The DACx3004W can operate with the power-supply pin (VDD) as a reference. Equation 4 shows DAC transfer function when the power-supply pin is used as reference. The gain at the output stage is always 1x.

$$V_{OUT} = \frac{DAC_DATA}{2^N} \times V_{DD}$$

where:

- N is the resolution in bits, 10 (DAC53004W) or 12 (DAC63004W).
- DAC_DATA is the decimal equivalent of the binary code that is loaded to the DAC-X-DATA bit in the DAC-X-DATA register.
- DAC_DATA ranges from 0 to 2^N 1.
- V_{DD} is used as the DAC reference voltage.

7.4.2 Current-Output Mode

To enter current-output mode for each DAC channel, disable the respective IOUT-PDN-X bits in the COMMON-CONFIG register, and set the respective VOUT-PDN-X bits in the same register to Hi-Z power-down mode. Select the desired current-output range by writing to the IOUT-RANGE-X bit in the DAC-X-IOUT-MISC-CONFIG register. To minimize leakage in current-output mode, disconnect the FBx pin. For the best power-on glitch performance, program the NVM with IOUT mode using the smallest output range before powering on the output channel, and then immediately program the DAC code and desired output range. The transfer function of the output current is shown in the following equation:

$$I_{OUT} = \frac{DAC_DATA \times (I_{MAX} - I_{MIN})}{2^8} + I_{MIN}$$
(5)

where:

- DAC_DATA is the decimal equivalent of the binary code that is loaded to the DAC-X-DATA bits specified in Section 7.6.8 or the DAC-X-DATA-8BIT bits specified in Section 7.6.19. DAC_DATA ranges from 0 to 255.
- I_{MAX} is the signed maximum current in the IOUT-RANGE-X setting specified in Section 7.6.5.
- I_{MIN} is the signed minimum current in the IOUT-RANGE-X setting specified in Section 7.6.5.



7.4.3 Comparator Mode

All the DAC channels can be configured as programmable comparators in the voltage-output mode. To enter the comparator mode for a channel, write 1 to the CMP-X-EN bit in the respective DAC-X-VOUT-CMP-CONFIG register. The comparator output can be configured as push-pull or open-drain using the CMP-X-OD-EN bit. To enable the comparator output on the output pin, write 1 to the CMP-X-OUT-EN bit. To invert the comparator output, write 1 to the CMP-X-INV-EN bit. The FBx pin has a finite impedance. By default, the FBx pin is in the high-impedance mode. To disable high-impedance on the FBx pin, write 1 to the CMP-X-HIZ-IN-DIS bit. Table 7-1 shows the comparator output at the pin for different bit settings.

Note

In the Hi-Z input mode, the comparator input range is limited to:

- For GAIN = 1x, 1.5x, or 2x: $V_{FB} \le (V_{REF} \times GAIN) / 3$
- For GAIN = 3x, or 4x: $V_{FB} \le (V_{REF} \times GAIN) / 6$

Any higher input voltage is clipped.

| CMP-X-EN | CMP-X-OUT-EN | CMP-X-OD-EN | CMP-X-INV-EN | CMPX-OUT PIN | | | |
|----------|--------------|-------------|--------------|--------------------------------|--|--|--|
| 0 | Х | Х | Х | Comparator not enabled | | | |
| 1 | 0 | Х | Х | No output | | | |
| 1 | 1 | 0 | 0 | Push-pull output | | | |
| 1 | 1 | 0 | 1 | Push-pull and inverted output | | | |
| 1 | 1 | 1 | 0 | Open-drain output | | | |
| 1 | 1 | 1 | 1 | Open-drain and inverted output | | | |

Table 7-1. Comparator Output Configuration

Figure 7-3 shows the interface circuit when all the DAC channels are configured as comparators. The programmable comparator operation is as shown in Figure 7-4. Individual comparator channels can be configured in no-hysteresis, with-hysteresis, and window-comparator modes using the CMP-X-MODE bit in the respective DAC-X-CMP-MODE-CONFIG register, as shown in Table 7-2.

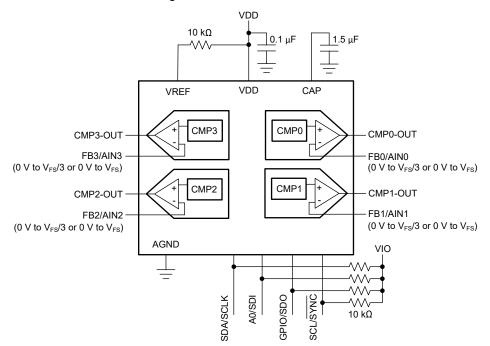


Figure 7-3. Comparator Interface



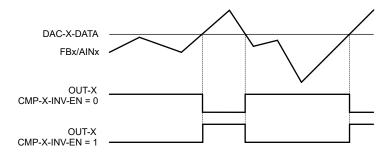


Figure 7-4. Programmable Comparator Operation

Table 7-2. Comparator Mode Selection

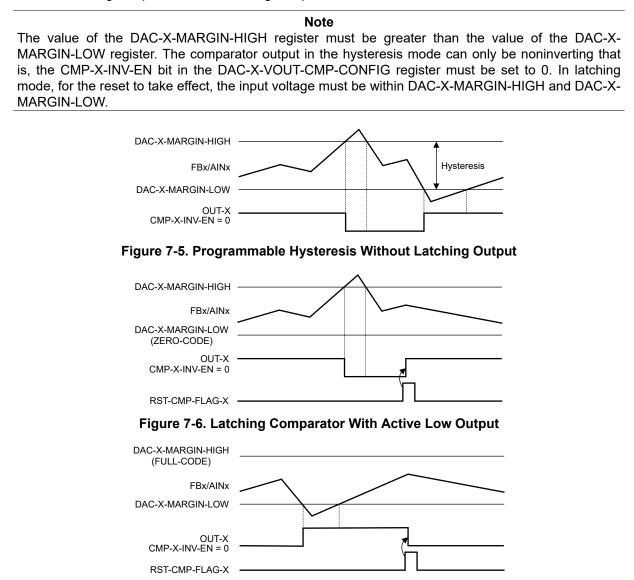
| CMP-X-MODE BIT FIELD | COMPARATOR CONFIGURATION |
|----------------------|--|
| 00 | Normal comparator mode. No hysteresis or window operation. |
| 01 | Hysteresis comparator mode. DAC-X-MARGIN-HIGH and DAC-X-MARGIN-LOW registers set the hysteresis. |
| 10 | Window comparator mode. DAC-X-MARGIN-HIGH and DAC-X-MARGIN-LOW registers set the window bounds. |
| 11 | Invalid setting |



7.4.3.1 Programmable Hysteresis Comparator

Comparator mode provides hysteresis when the CMP-X-MODE bit is set to 01b, as shown in Table 7-2. The hysteresis is provided by the DAC-X-MARGIN-HIGH and DAC-X-MARGIN-LOW registers, as shown in Figure 7-5.

When the DAC-X-MARGIN-HIGH is set to full-code or the DAC-X-MARGIN-LOW is set to zero-code, the comparator works as a latching comparator that is, the output is latched after the threshold is crossed. The latched output can be reset by writing to the corresponding RST-CMP-FLAG-X bit in the COMMON-DAC-TRIG register. Figure 7-6 shows the behavior of a latching comparator with active low output and Figure 7-7 shows the behavior of a latching comparator with active high output.







7.4.3.2 Programmable Window Comparator

Window comparator mode is enabled by setting the CMP-X-MODE bit to 10b, as shown in Table 7-2. The window bounds are set by the DAC-X-MARGIN-HIGH and the DAC-X-MARGIN-LOW registers, as shown in Figure 7-8. The output of the window comparator for a given channel is indicated by the respective WIN-CMP-X bit in the CMP-STATUS register. The comparator output (WIN-CMP-X) can be latched by writing 1 to the WIN-LATCH-EN bit in the COMMON-CONFIG register. After being latched, the comparator output can be reset using the corresponding RST-CMP-FLAG-X bit in the COMMON-DAC-TRIG register. For the reset to take effect, the input must be within the window bounds.

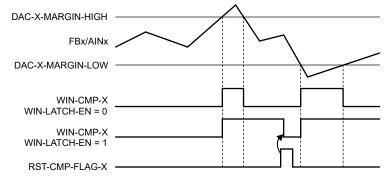


Figure 7-8. Window Comparator Operation

A single comparator is used per channel to check both the *margin-high* and *margin-low* limits of the window. Therefore, the window comparator function has a finite response time as specified in the *Electrical Characteristics: Comparator Mode* section. Also, the static behavior of the WIN-CMP-X bit is not reflected at the output pins. Set the CMP-X-OUT-EN bit to 0. The WIN-CMP-X bit must be read digitally using the communication interface. This bit can also be mapped to the GPIO pin, as shown in Table 7-19.

Note

- The value of the DAC-X-MARGIN-HIGH register must be greater than that of the DAC-X-MARGIN-LOW register.
- Set the SLEW-RATE-X bit to 0000b (no-slew) and LOG-SLEW-EN-X bit to 0b in the DAC-X-FUNC-CONFIG register to get the best response time from the window comparator.
- The CMP-X-OUT-EN bit in the DAC-X-VOUT-CMP-CONFIG register can be set to 0b to eliminate undesired toggling of the OUT pin.

7.4.4 Fault-Dump Mode

The DACx3004W provides a feature to save a few registers into the NVM when the FAULT-DUMP bit is triggered or the GPIO mapped to fault-dump (as shown in Table 7-18) is triggered. This feature is useful in system-level fault management to capture the state of the device or system just before a fault is triggered, to allow diagnosis after the fault has occurred. The registers saved when fault-dump is triggered, are:

- CMP-STATUS[7:0]
- DAC-0-DATA[15:8]
- DAC-1-DATA[15:8]
- DAC-2-DATA[15:8]
- DAC-3-DATA[15:8]

Note

When the fault-dump cycle is in progress, any change in the data can corrupt the final outcome. Make sure the comparator and the DAC codes are stable during the NVM write cycle.

Table 7-3 shows the storage format of the registers in the NVM.



Table 7-3. Fault-Dump NVM Storage Format

| NVM ROWS | B31-B24 | B23-B16 | B7-B0 | | |
|----------|------------------|--|-------|--|--|
| Row1 | CMP-STATUS[7:0] | Don't care | | | |
| Row2 | DAC-0-DATA[15:8] | DAC-1-DATA[15:8] DAC-2-DATA[15:8] DAC-3-DATA[1 | | | |

The data captured in the NVM after the fault dump can be read in a specific sequence:

- 1. Set the EE-READ-ADDR bit to 0b in the COMMON-CONFIG register, to select row1 of the NVM.
- Trigger the read of the selected NVM row by writing 1 to the READ-ONE-TRIG in the COMMON-TRIGGER register; this bit autoresets. This action copies that data from the selected NVM row to SRAM addresses 0x9D (LSB 16 bits from the NVM) and 0x9E (MSB 16 bits from the NVM).
- 3. To read the SRAM data:
 - a. Write 0x009D to the SRAM-CONFIG register.
 - b. Read the data from the SRAM-DATA register to get the LSB 16 bits.
 - c. Write 0x009E to the SRAM-CONFIG register.
 - d. Read the data from the SRAM-DATA register again to get the MSB bits.
- 4. Set the EE-READ-ADDR bit to 1b in the COMMON-CONFIG register, to select row2 of the NVM. Repeat steps 2 and 3.

7.4.5 Application-Specific Modes

This section provides the details of application-specific functional modes available in DACx3004W.

7.4.5.1 Voltage Margining and Scaling

Voltage margining or scaling is a primary application for DACx3004W. This section provides specific features available for this application such as Hi-Z output, slew-rate control, **PROTECT** input, and PMBus compatibility.

7.4.5.1.1 High-Impedance Output and PROTECT Input

All the DAC output channels remain in high-impedance (Hi-Z) when VDD is off. Figure 7-9 shows a simplified schematic of DACx3004W used in a voltage-margining application. The series resistor R_S is needed in voltage-output mode, but is optional in current-output mode. Almost all linear regulators and DC/DC converters have a feedback voltage of ≤ 1.25 V. The low-leakage currents at the outputs are maintained for V_{FB} of ≤ 1.25 V. Thus, for all practical purposes, the DAC outputs appear as Hi-Z when VDD of the DAC is off in voltage margining and scaling applications. This feature allows for seamless integration of the DACx3004W into a system without any need for additional power-supply sequencing for the DAC.

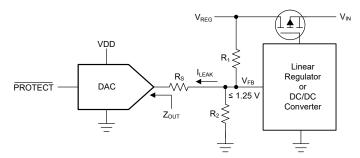


Figure 7-9. High-Impedance (Hi-Z) Output and PROTECT Input

The DAC channels power down to Hi-Z at boot up. The outputs can power up with a preprogrammed code that corresponds to the nominal output of the DC/DC converter or the linear regulator. This feature allows for smooth power up and power down of the DAC without impacting the feedback loop of the DC/DC converter or the linear regulator.

The GPIO pin of the DACx3004W can be configured as a **PROTECT** function, as shown in **Table 7-18**. **PROTECT** takes the DAC outputs to a predictable state with a slewed or direct transition. This function is useful in systems where a fault condition (such as a brownout), a subsystem failure, or a software crash requires that the DAC outputs reach a predefined state without the involvement of a processor. The detected event can be fed to the GPIO pin that is configured as the **PROTECT** input. The **PROTECT** function can also be triggered



using the PROTECT bit in the COMMON-TRIGGER register. Configure the behavior of the PROTECT function in the PROTECT-CONFIG field in the DEVICE-MODE-CONFIG register, as shown in Table 7-4.

Note

- After the **PROTECT** function is triggered, the write functionality is disabled on the communication interface until the function is completed.
- The PROTECT-FLAG bit in the CMP-STATUS register is set to 1 when the PROTECT function is triggered. This bit can be polled by reading the CMP-STATUS register. After the PROTECT function is complete, a read command on the CMP-STATUS register resets the PROTECT-FLAG bit.

| Iddi | |
|----------------------|--|
| PROTECT-CONFIG FIELD | FUNCTION |
| 00 | Switch to Hi-Z power-down (no slew). |
| 01 | Switch to DAC code stored in NVM (no slew) and then switch to Hi-Z power-down. |
| 10 | Slew to margin-low code and then switch to Hi-Z power-down. |
| 11 | Slew to margin-high code and then switch to Hi-Z power-down. |

Table 7-4. PROTECT Function Configuration

7.4.5.1.2 Programmable Slew-Rate Control

When the DAC data registers are written, the voltage on DAC output (V_{OUT}) immediately transitions to the new code following the slew rate and settling time specified in the *Electrical Characteristics*.

The slew rate control feature allows the user to control the rate at which the output voltage (V_{OUT}) changes. When this feature is enabled (using the SLEW-RATE-X[3:0] bits), the DAC output changes from the current code to the code in the DAC-X-MARGIN-HIGH or DAC-X-MARGIN-LOW registers (when margin high or low commands are issued to the DAC) using the step size and time-period per step set in CODE-STEP-X and SLEW-RATE-X bits in the DAC-X-FUNC-CONFIG register:

- SLEW-RATE-X defines the time-period per step at which the digital slew updates.
- CODE-STEP-X defines the number of LSBs by which the output value changes at each update, for the corresponding channels.

Table 7-5 and Table 7-6 show different settings available for CODE-STEP-X and SLEW-RATE-X. With the default slew rate control setting of no-slew, the output changes immediately at a rate limited by the output drive circuitry and the attached load.

When the slew rate control feature is used, the output changes happen at the programmed slew rate. This configuration results in a staircase formation at the output as shown in Figure 7-10. Do not write to CODE-STEP-X, SLEW-RATE-X, or DAC-X-DATA during the output slew operation. Equation 6 provides the equation for the calculating the slew time (t_{SLEW}).



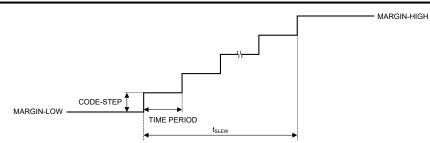


Figure 7-10. Programmable Slew-Rate Control

$$t_{SLEW} = SLEW_RATE \times CEILING\left(\frac{MARGIN_HIGH - MARGIN_LOW}{CODE_STEP} + 1\right)$$
(6)

where:

- SLEW_RATE is the SLEW-RATE-X setting as specified in Table 7-6.
- CODE_STEP is the CODE-STEP-X setting as specified in Table 7-5.
- MARGIN_HIGH is the decimal value of the DAC-X-MAGIN-HIGH bits specified in the DAC-X-MARGIN-HIGH register.
- MARGIN_LOW is the decimal value of the DAC-X-MAGIN-LOW bits specified in the DAC-X-MARGIN-LOW register.

| | | Table 7-5. Code Step | | |
|-------------------|----------------|----------------------|----------------|-----------------|
| REGISTER | CODE-STEP-X[2] | CODE-STEP-X[1] | CODE-STEP-X[0] | CODE STEP SIZE |
| | 0 | 0 | 0 | 1 LSB (default) |
| | 0 | 0 | 1 | 2 LSB |
| | 0 | 1 | 0 | 3 LSB |
| DAC-X-FUNC-CONFIG | 0 | 1 | 1 | 4 LSB |
| DAC-X-FUNC-CUNFIG | 1 | 0 | 0 | 6 LSB |
| | 1 | 0 | 1 | 8 LSB |
| | 1 | 1 | 0 | 16 LSB |
| | 1 | 1 | 1 | 32 LSB |

Table 7-6. Slew Rate

| REGISTER | SLEW-RATE-X[3] | SLEW-RATE-X[2] | SLEW-RATE-X[1] | SLEW-RATE-X[0] | TIME PERIOD (PER STEP) |
|-------------------|----------------|----------------|----------------|----------------|---------------------------|
| | 0 | 0 | 0 | 0 | No slew (default) |
| | 0 | 0 | 0 | 1 | 4 µs |
| | 0 | 0 | 1 | 0 | 8 µs |
| | 0 | 0 | 1 | 1 | 12 µs |
| | 0 | 1 | 0 | 0 | 18 µs |
| | 0 | 1 | 0 | 1 | 27.04 μs |
| | 0 | 1 | 1 | 0 | 40.48 µs |
| DAC-X-FUNC-CONFIG | 0 | 1 | 1 | 1 | 60.72 μs |
| DAC-X-FUNC-CONFIG | 1 | 0 | 0 | 0 | 91.12 μs |
| | 1 | 0 | 0 | 1 | 136.72 µs |
| | 1 | 0 | 1 | 0 | 239.2 µs |
| | 1 | 0 | 1 | 1 | 418.64 µs |
| | 1 | 1 | 0 | 0 | 732.56 µs |
| | 1 | 1 | 0 | | 1282 µs |
| | 1 | 1 | 1 | 0 | 2563.96 µs |
| | 1 | 1 | 1 | 1 | 5127.92 µs |



7.4.5.1.3 PMBus Compatibility Mode

The PMBus protocol is an I²C-based communication standard for power-supply management. PMBus contains standard command codes tailored to power supply applications. The DACx3004W implement some PMBus commands such as *Turn Off, Turn On, Margin Low, Margin High, Communication Failure Alert Bit (CML)*, as well as *PMBUS revision*. Figure 7-11 shows typical PMBus connections. The EN-PMBUS bit in the INTERFACE-CONFIG register must be set to 1 to enable the PMBus protocol.

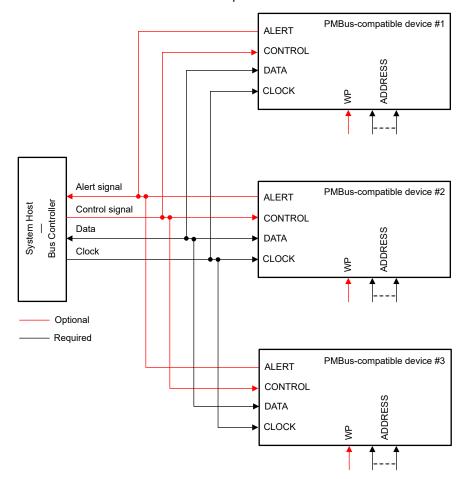


Figure 7-11. PMBus Connections



Similar to I²C, PMBus is a variable length packet of 8-bit data bytes, each with a receiver acknowledge, wrapped between a start and stop bit. The first byte is always a 7-bit *target address* followed by a *write* bit, sometimes called the *even address* that identifies the intended receiver of the packet. The second byte is an 8-bit *command* byte, identifying the PMBus command being transmitted using the respective command code. After the command byte, the transmitter either sends data associated with the command to write to the receiver command register (from least significant byte to most significant byte, as shown in Table 7-7), or sends a new start bit indicating the desire to read the data associated with the command register from the receiver. Then the receiver transmits the data following the same least significant byte first format (see Table 7-8).

| MSB | | LSB | ACK | MSB | | LSB | ACK | MSB | | LSB | ACK | MSB | | LSB | ACK |
|-----|-------------------------|-----|-----|------------|-----------------------|-----|-----------------|------|--|-----|-----|-----|----------|-----|-----|
| | lress (A) tion 7.5.2 | | | | mmand b tion 7.5.2 | , | | Data | Data byte - LSDB Data byte - MSDB (Optional) | | | | | | |
| 0 | OB [31:24 |] | | DB [23:16] | | | 3:16] DB [15:8] | | | | | | DB [7:0] | | |

Table 7-7. PMBus Update Sequence

| s | MSB | | R/W (0) | ACK | MSB | | LSB | ACK | Sr | MSB | | R/W (1) | ACK | MSB | | LSB | ACK | MSB | | LSB | ACK | | |
|---|--------|-------|-----------------|--------|------|-----|-----------------|--------|----|-----------------------------------|--|------------|-------------|-----|-------------|------|-----------------------|---------|------------|-----|------|------|------------|
| | | | BYTE 5.2.2.1 | | | | BYTE 5.2.2.2 | | Sr | ADDRESS BYTE Section 7.5.2.2.1 | | | LSDB | | | MSDE | B (Op | tional) | | | | | |
| | From C | ontro | ller | Target | From | Con | troller | Target | | From Controller | | Target | From Target | | From Target | | From Target Controlle | | Controller | Fro | m Ta | rget | Controller |

Table 7-8. PMBus Read Sequence

The DACx3004W I²C interface implements some of the PMBus commands. Table 7-9 shows the supported PMBus commands that are implemented in DACx3004W. The DAC uses DAC-X-MARGIN-LOW, DAC-X-MARGIN-HIGH bits, SLEW-RATE-X, and CODE-STEP-X bits for PMBUS-OPERATION-CMD-X. To access multiple channels, write the PMBus page address as specified in the *Register Names* table in the *Register Map* section to the PMBUS-PAGE register first, followed by a write to the channel-specific register.

| | Table 7-9. PMBus Operation Commands | | | | | | | | | | | | |
|------------------|-------------------------------------|-------------|--|--|--|--|--|--|--|--|--|--|--|
| REGISTER | PMBUS-OPERATION-CMD-X[15:8] | DESCRIPTION | | | | | | | | | | | |
| | 00h | Turn off | | | | | | | | | | | |
| PMBUS-OP-CMD-X | 80h | Turn on | | | | | | | | | | | |
| FINDUS-OF-CIND-A | 94h | Margin low | | | | | | | | | | | |
| | A4h | Margin high | | | | | | | | | | | |

The DACx3004W also implement PMBus features such as group command protocol and communication timeout failure. The CML bit in the PMBUS-CML register indicates a communication fault in the PMBus. This bit is reset by writing 1.

To get the PMBus version, read the PMBUS-VERSION register.



7.4.5.2 Function Generation

The DACx3004W implement a continuous function or waveform generation feature. These devices can generate a triangular wave, sawtooth wave, and sine wave independently for every channel.

7.4.5.2.1 Triangular Waveform Generation

Figure 7-12 shows that the triangular waveform uses the DAC-X-MARGIN-LOW (FUNCTION-MIN) and DAC-X-MARGIN-HIGH (FUNCTION-MAX) registers for minimum and maximum levels, respectively. The frequency of the waveform depends on the min and max levels, CODE-STEP and SLEW-RATE settings as shown in Equation 7. An external RC load with a time-constant larger than the slew-rate settings can be dominant over the internal frequency calculation. The CODE-STEP-X and SLEW-RATE-X settings are available in the DAC-X-FUNC-CONFIG register. Writing 0b000 to the FUNC-CONFIG-X bit field in the DAC-X-FUNC-CONFIG register selects triangular waveform.

$$f_{TRIANGLE} = \frac{1}{2 \times TIME_STEP \times CEILING\left(\frac{FUNCTION_MAX - FUNCTION_MIN}{CODE_STEP}\right)}$$
(7)

where:

- TIME_STEP is the SLEW-RATE-X setting as specified in Table 7-6.
- CODE_STEP is the CODE-STEP-X setting as specified in Table 7-5.
- FUNCTION_MAX is the decimal value of DAC-X-MAGIN-HIGH bits specified in the DAC-X-MARGIN-HIGH register.
- FUNCTION_MIN is the decimal value of the DAC-X-MAGIN-LOW bits specified in the DAC-X-MARGIN-LOW register.

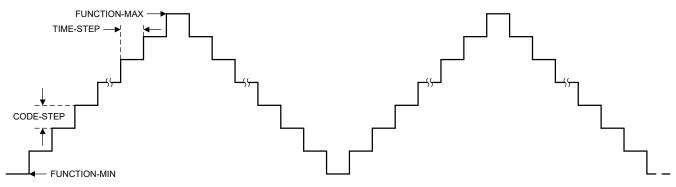


Figure 7-12. Triangle Waveform



7.4.5.2.2 Sawtooth Waveform Generation

Figure 7-13 shows the sawtooth and the inverse sawtooth waveforms use the DAC-X-MARGIN-LOW (FUNCTION-MIN) and DAC-X-MARGIN-HIGH (FUNCTION-MAX) registers for minimum and maximum levels, respectively. The frequency of the waveform depends on the min and max levels, CODE-STEP and SLEW-RATE settings as shown in Equation 8. An external RC load with a time constant larger than the slew-rate settings can be dominant over the internal frequency calculation. The CODE-STEP-X and SLEW-RATE-X settings are available in the DAC-X-FUNC-CONFIG register. Write 0b001 to the FUNC-CONFIG-X bit field in the DAC-X-FUNC-CONFIG register to select sawtooth waveform, and write 0b010 to select inverse sawtooth waveform.

$$f_{SAWTOOTH} = \frac{1}{TIME_STEP \times CEILING\left(\frac{FUNCTION_MAX - FUNCTION_MIN}{CODE_STEP} + 1\right)}$$
(8)

where:

- TIME_STEP is the SLEW-RATE-X setting as specified in Table 7-6.
- CODE_STEP is the CODE-STEP-X setting as specified in Table 7-5.
- FUNCTION_MAX is the decimal value of the DAC-X-MAGIN-HIGH bits specified in the DAC-X-MARGIN-HIGH register.
- FUNCTION_MIN is the decimal value of the DAC-X-MAGIN-LOW bits specified in the DAC-X-MARGIN-LOW.

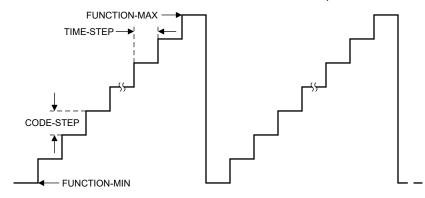


Figure 7-13. Sawtooth Waveform



(9)

7.4.5.2.3 Sine Waveform Generation

The sine wave function uses 24 preprogrammed points per cycle. The frequency of the sine wave depends on the SLEW-RATE settings as shown in Equation 9:

$f_{SINE_WAVE} = \frac{1}{24 \times SLEW_RATE}$

where SLEW RATE is the SLEW-RATE-X setting as specified in Table 7-6.

An external RC load with a time constant larger than the slew-rate settings can be dominant over the internal frequency calculation. The SLEW-RATE-X setting is available in the DAC-X-FUNC-CONFIG register. Writing 0b100 to the FUNC-CONFIG-X bit field in the DAC-X-FUNC-CONFIG register selects sine wave. The codes for the sine wave are fixed. Use the gain settings at the output amplifier for changing the full-scale output using the internal reference option. The gain settings are accessible through the VOUT-GAIN-X bits in the DAC-X-VOUT-CMP-CONFIG register. Table 7-10 shows the list of hard-coded discrete points for the sine wave with 12-bit resolution and Figure 7-14 shows the pictorial representation of the sine wave. There are four phase settings available for the sine wave that are selected using the PHASE-SEL-X bit in the DAC-X-FUNC-CONFIG register.

| SEQUENCE | 12-BIT VALUE | SEQUENCE | 12-BIT VALUE |
|----------------------|--------------|-----------------------|--------------|
| 0 (0° phase start) | 0x800 | 12 | 0x800 |
| 1 | 0x9A8 | 13 | 0x658 |
| 2 | 0xB33 | 14 | 0x4CD |
| 3 | 0xC87 | 15 | 0x379 |
| 4 | 0xD8B | 16 (240° phase start) | 0x275 |
| 5 | 0xE2F | 17 | 0x1D1 |
| 6 (90° phase start) | 0xE66 | 18 | 0x19A |
| 7 | 0xE2F | 19 | 0x1D1 |
| 8 (120° phase start) | 0xD8B | 20 | 0x275 |
| 9 | 0xC87 | 21 | 0x379 |
| 10 | 0xB33 | 22 | 0x4CD |
| 11 | 0x9A8 | 23 | 0x658 |

Table 7-10. Sine Wave Data Points

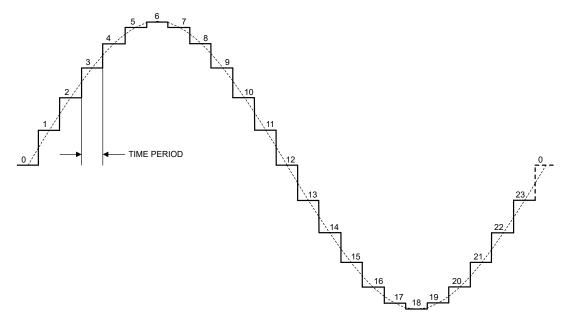


Figure 7-14. Sine Wave Generation



7.4.6 Device Reset and Fault Management

This section provides the details of power-on-reset (POR), software reset, and other diagnostics and fault-management features of DACx3004W.

7.4.6.1 Power-On Reset (POR)

The DACx3004W family of devices includes a power-on reset (POR) function that controls the output voltage at power up. After the V_{DD} supply has been established, a POR event is issued. The POR causes all registers to initialize to default values, and communication with the device is valid only after a POR (boot-up) delay. The default value for all the registers in the DACx3004W is loaded from NVM as soon as the POR event is issued.

When the device powers up, a POR circuit sets the device to the default mode. The POR circuit requires specific V_{DD} levels, as indicated in Figure 7-15, to make sure that the internal capacitors discharge and reset the device at power up. To make sure that a POR occurs, V_{DD} must be less than 0.7 V for at least 1 ms. When V_{DD} drops to less than 1.65 V, but remains greater than 0.7 V (shown as the undefined region), the device may or may not reset under all specified temperature and power-supply conditions. In this case, initiate a POR. When V_{DD} remains greater than 1.65 V, a POR does not occur.

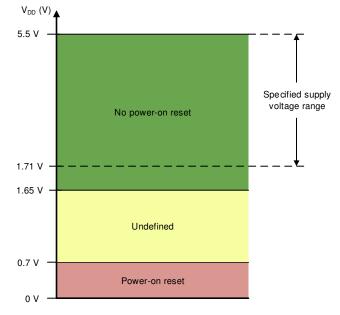


Figure 7-15. Threshold Levels for V_{DD} POR Circuit

7.4.6.2 External Reset

An external reset to the device can be triggered through the GPIO pin or through the register map. To initiate a device software reset event, write the reserved code 1010b to the RESET field in the COMMON-TRIGGER register. A software reset initiates a POR event. The GPIO pin can be configured as a RESET pin as shown in Table 7-18. This configuration must be programmed into the NVM so that the setting is not cleared after the device reset. The RESET input must be a low pulse. The device starts the boot-up sequence after the falling edge of the RESET input. The rising edge of the RESET input does not have any effect.

7.4.6.3 Register-Map Lock

The DACx3004W implement a register-map lock feature that prevents an accidental or unintended write to the DAC registers. The device locks all the registers when the DEV-LOCK bit in the COMMON-CONFIG register is set to 1. However, the software reset function through the COMMON-TRIGGER register is not blocked when using I²C interface. To bypass the DEV-LOCK setting, write 0101b to the DEV-UNLOCK bits in the COMMON-TRIGGER register.



7.4.6.4 NVM Cyclic Redundancy Check (CRC)

The DACx3004W implement a cyclic redundancy check (CRC) feature for the NVM to make sure that the data stored in the NVM is uncorrupted. There are two types of CRC alarm bits implemented in DACx3004W:

- NVM-CRC-FAIL-USER
- NVM-CRC-FAIL-INT

The NVM-CRC-FAIL-USER bit indicates the status of user-programmable NVM bits, and the NVM-CRC-FAIL-INT bit indicates the status of internal NVM bits The CRC feature is implemented by storing a 16-Bit CRC (CRC-16-CCITT) along with the NVM data each time NVM program operation (write or reload) is performed and during the device start up. The device reads the NVM data and validates the data with the stored CRC. The CRC alarm bits (NVM-CRC-FAIL-USER and NVM-CRC-FAIL-INT in the GENERAL-STATUS register) report any errors after the data are read from the device NVM. The alarm bits are set only at boot-up.

7.4.6.4.1 NVM-CRC-FAIL-USER Bit

A logic 1 on NVM-CRC-FAIL-USER bit indicates that the user-programmable NVM data are corrupt. During this condition, all registers in the DAC are initialized with factory reset values, and any DAC registers can be written to or read from. To reset the alarm bits to 0, issue a software reset (see *Section 7.4.6.2*) command, or cycle power to the DAC. A software reset or power-cycle also reloads the user-programmable NVM bits. In case the failure persists, reprogram the NVM.

7.4.6.4.2 NVM-CRC-FAIL-INT Bit

A logic 1 on NVM-CRC-FAIL-INT bit indicates that the internal NVM data are corrupt. During this condition, all registers in the DAC are initialized with factory reset values, and any DAC registers can be written to or read from. In case of a temporary failure, to reset the alarm bits to 0, issue a software reset (see Section 7.4.6.2) command or cycle power to the DAC. A permanent failure in the NVM makes the device unusable.



7.4.7 Power-Down Mode

The DACx3004W output amplifier and internal reference can be independently powered down through the EN-INT-REF, VOUT-PDN-X, and IOUT-PDN-X bits in the COMMON-CONFIG register, as shown in Figure 7-2. At power up, the DAC output and the internal reference are disabled by default. In power-down mode, the DAC outputs (OUTx pins) are in a high-impedance state. To change this state to 10 k Ω -AGND or 100 k Ω -AGND in the voltage-output mode (at power up), use the VOUT-PDN-X bits. The power-down state for current-output mode is always high-impedance.

The DAC power-up state can be programmed to any state (power-down or normal mode) using the NVM. Table 7-11 shows the DAC power-down bits. The individual channel power-down bits or the global device power-down function can be mapped to the GPIO pin using the GPIO-CONFIG register.

| REGISTER | VOUT-PDN-X[1] | VOUT-PDN-X[0] | IOUT-PDN-X | DESCRIPTION |
|---------------|---------------|---------------|------------|---|
| | 0 | 0 | 1 | Power up VOUT-X. |
| | 0 | 1 | 1 | Power down VOUT-X with 10 k Ω to AGND. Power down IOUT-X to Hi-Z. |
| COMMON-CONFIG | 1 | 0 | 1 | Power down VOUT-X with 100 k Ω to AGND. Power down IOUT-X to Hi-Z. |
| | 1 | 1 | 1 | Power down VOUT-X to Hi-Z. Power down IOUT-X to Hi-Z (default). |
| | 1 | 1 | 0 | Power down VOUT-X to Hi-Z. Power up IOUT-X. |

Table 7-11. DAC Power-Down Bits



7.5 Programming

The DACx3004W are programmed through either a 3-wire SPI or 2-wire I^2C interface. A 4-wire SPI mode is enabled by mapping the GPIO pin as SDO. The SPI readback operates at a lower SCLK than the standard SPI write operation. The type of interface is determined based on the first protocol to communicate after device power up. After the interface type is determined, the device ignores any change in the type while the device is on. The interface type can be changed after a power cycle.

7.5.1 SPI Programming Mode

An SPI access cycle for DACx3004W is initiated by asserting the SYNC pin low. The serial clock, SCLK, can be a continuous or gated clock. SDI data are clocked on SCLK falling edges. The SPI frame for DACx3004W is 24 bits long. Therefore, the SYNC pin must stay low for at least 24 SCLK falling edges. The access cycle ends when the SYNC pin is deasserted high. If the access cycle contains less than the minimum clock edges, the communication is ignored. By default, the SDO pin is not enabled (three-wire SPI). In the three-wire SPI mode, if the access cycle contains more than the minimum clock edges, only the first 24 bits are used by the device. When SYNC is high, the SCLK and SDI signals are blocked, and SDO becomes Hi-Z to allow data readback from other devices connected on the bus.

Table 7-12 and Figure 7-16 describe the format for the 24-bit SPI access cycle. The first byte input to SDI is the instruction cycle. The instruction cycle identifies the request as a read or write command and the 7-bit address that is to be accessed. The last 16 bits in the cycle form the data cycle.

| i | BIT | FIE | LD | | | | | D | ESCRIPT | ION | | | | | |
|-------|-----|----------|-------------|----------|---------|-----------------------------|--|------------------------------|---------|-------------|---------------|----------------------------|-------------|---|--|
| 23 | | R/W | | | | nmunication 1 sets a rea | | | command | l to the ad | dress registe | er: R/ W = 0 se | ets a write | Э | |
| 22-16 | | A[6:0] | | Register | address | : specifies t | s the register to be accessed during the read or write operation | | | | | | | | |
| 15-0 | | DI[15:0] | | | | | | , the data cy the data cy | | | | ten to the reg | ister with | I | |
| | | | | | | | | | | | | | | | |
| SCLK | | | 8 | 9 | | 24 | | 1 | | 8 | 9 | | 24 | | |
| | | | Write comma | and | | | • | • | | Any comm | and ——— | | | | |
| SDI | D23 | 3 | D16 | D15 | | D0 | | D23 | | D16 | D15 | | D0 | | |
| | HiZ | | | | | | _HiZ_ | • | | Write comm | nand echo — | | → HiZ | 2 | |
| SDO - | | | | | | | | D23 | | D16 | D15 | | D0 | | |

Table 7-12. SPI Read/Write Access Cycle

Figure 7-16. SPI Write Cycle

Read operations require that the SDO pin is first enabled by setting the SDO-EN bit in the INTERFACE-CONFIG register. This configuration is called four-wire SPI. A read operation is initiated by issuing a read command access cycle. After the read command, a second access cycle must be issued to get the requested data. The output data format is shown in Table 7-13 and Figure 7-17. Data are clocked out on the SDO pin either on the falling edge or rising edge of SCLK according to the FSDO bit, as shown in Figure 6-3.

| BIT | FIELD | DESCRIPTION |
|-------|----------|--|
| 23 | R/W | Echo R/W from previous access cycle |
| 22-16 | A[6:0] | Echo register address from previous access cycle |
| 15-0 | DI[15:0] | Readback data requested on previous access cycle |

Table 7-13. SDO Output Access Cycle

| | | , DAC630 RCH 2023 |)4W | | | | | | | | Texa Inst | S RUMENTS www.ti.com | |
|-------|-----|-----------------------------|-----|-----------|---------|--------|-----|-----|----------------|---------|--------------|----------------------------|--|
| SYNC | | | | | | | | | | | | | |
| SCLK | | | | 8 | 9 | 24 | | 1 | 8 | 9 | | 24 | |
| | | • | | Read comm | and ——— | | | • | - Any comm | and ——— | | | |
| SDI | | D23 | | D16 | D15 | D0 | | D23 | D16 | D15 | | D0 | |
| SDO - | HiZ | | | | | | HIZ | D23 | D16 | D15 | Read Data | → HiZ | |
| | | | | | | | | | _ | | | | |

Figure 7-17. SPI Read Cycle

The daisy-chain operation is also enabled with the SDO pin. In daisy-chain mode, multiple devices are connected in a *chain* with the SDO pin of one device is connected to SDI pin of the following device, as shown in Figure 7-18. The SPI host drives the SDI pin of the first device in the chain. The SDO pin of the last device in the chain is connected to the POCI pin of the SPI host. In four-wire SPI mode, if the access cycle contains multiples of 24 clock edges, only the last 24 bits are used by the device first device in the chain. If the access cycle contains clock edges that are not in multiples of 24, the SPI packet is ignored by the device. Figure 7-19 describes the packet format for the daisy-chain write cycle.

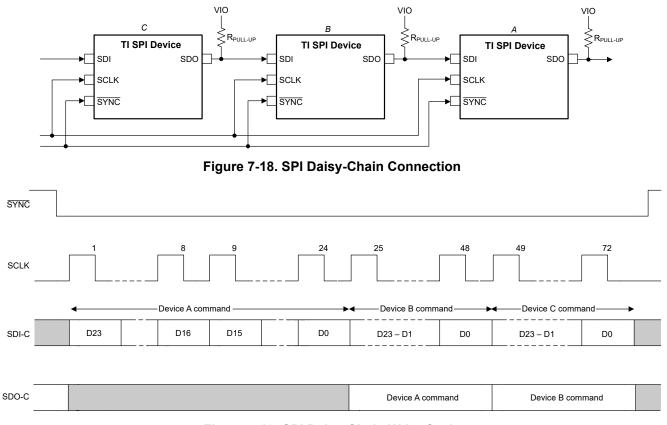


Figure 7-19. SPI Daisy-Chain Write Cycle

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7.5.2 I²C Programming Mode

The DACx3004W devices have a 2-wire serial interface (SCL and SDA), and one address pin (A0), as shown in the pin diagram in the *Pin Configuration and Functions* section. The I^2C bus consists of a data line (SDA) and a clock line (SCL) with pullup structures. When the bus is idle, both SDA and SCL lines are pulled high. All the I^2C -compatible devices connect to the I^2C bus through the open drain I/O pins, SDA and SCL.

The I²C specification states that the device that controls communication is called a *controller*, and the devices that are controlled by the controller are called *targets*. The controller generates the SCL signal. The controller also generates special timing conditions (start condition, repeated start condition, and stop condition) on the bus to indicate the start or stop of a data transfer. Device addressing is completed by the controller. The controller on an I²C bus is typically a microcontroller or digital signal processor (DSP). The DACx3004W family operates as a target on the I²C bus. A target acknowledges controller commands, and upon controller control, receives or transmits data.

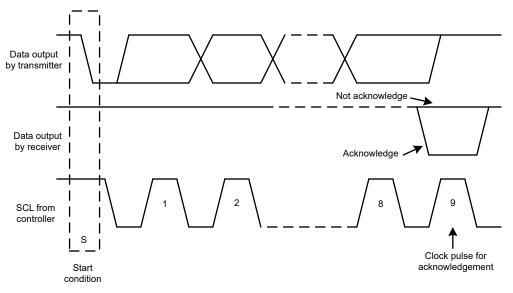
Typically, the DACx3004W family operates as a target receiver. A controller writes to the DACx3004W, a target receiver. However, if a controller requires the DACx3004W internal register data, the DACx3004W operate as a target transmitter. In this case, the controller reads from the DACx3004W. According to I²C terminology, read and write refer to the controller.

The DACx3004W family supports the following data transfer modes:

- Standard mode (100Kbps)
- Fast mode (400Kbps)
- Fast mode plus (1.0Mbps)

The data transfer protocol for standard and fast modes is exactly the same; therefore, both modes are referred to as *F/S-mode* in this document. The fast mode plus protocol is supported in terms of data transfer speed, but not output current. The low-level output current is 3 mA; similar to the case of standard and fast modes. The DACx3004W family supports 7-bit addressing. The 10-bit addressing mode is not supported. The device supports the general call reset function. Sending the following sequence initiates a software reset within the device: start or repeated start, 0x00, 0x06, stop. The reset is asserted within the device on the rising edge of the ACK bit, following the second byte.

Other than specific timing signals, the I²C interface works with serial bytes. At the end of each byte, a ninth clock cycle generates and detects an acknowledge signal. An acknowledge is when the SDA line is pulled low during the high period of the ninth clock cycle. A not-acknowledge is when the SDA line is left high during the high period of the ninth clock cycle, as shown in Figure 7-20.







7.5.2.1 F/S Mode Protocol

The following steps explain a complete transaction in F/S mode.

- The controller initiates data transfer by generating a start condition. The start condition is when a high-to-low transition occurs on the SDA line while SCL is high, as shown in Figure 7-21. All I²C-compatible devices recognize a start condition.
- 2. The controller then generates the SCL pulses, and transmits the 7-bit address and the read/write direction bit (R/W) on the SDA line. During all transmissions, the controller makes sure that data are valid. A valid data condition requires the SDA line to be stable during the entire high period of the clock pulse, as shown in Figure 7-22. All devices recognize the address sent by the controller and compare the address to the respective internal fixed address. Only the target device with a matching address generates an acknowledge by pulling the SDA line low during the entire high period of the 9th SCL cycle, as shown in Figure 7-20. When the controller detects this acknowledge, the communication link with a target has been established.
- 3. The controller generates further SCL cycles to transmit (R/W bit 0) or receive (R/W bit 1) data to the target. In either case, the receiver must acknowledge the data sent by the transmitter. The acknowledge signal can be generated by the controller or by the target, depending on which is the receiver. The 9-bit valid data sequences consists of eight data bits and one acknowledge-bit, and can continue as long as necessary.
- 4. To signal the end of the data transfer, the controller generates a stop condition by pulling the SDA line from low-to-high while the SCL line is high, as shown in Figure 7-21. This action releases the bus and stops the communication link with the addressed target. All I²C-compatible devices recognize the stop condition. Upon receipt of a stop condition, the bus is released, and all target devices then wait for a start condition followed by a matching address.

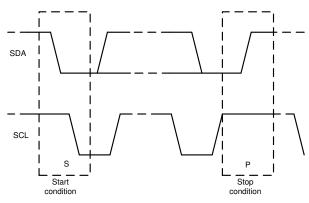


Figure 7-21. Start and Stop Conditions

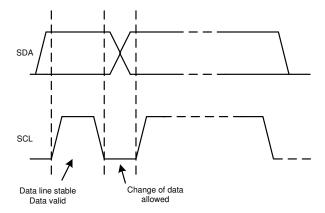


Figure 7-22. Bit Transfer on the I²C Bus



7.5.2.2 I²C Update Sequence

For a single update, the DACx3004W require a start condition, a valid I^2C address byte, a command byte, and two data bytes, as listed in Table 7-14.

| | | | | | | | | | 9999 | | | | | | |
|-----|------------------------|-----|-----|-----|-----------------------|-----|-----|-----------|-----------------------------------|-----|-----|-----|----------|-----|-----|
| MSB | | LSB | ACK | MSB | | LSB | ACK | MSB | | LSB | ACK | MSB | | LSB | ACK |
| | ress (A) tion 7.5.2 | | | | mmand b tion 7.5.2 | | | Data | Data byte - MSDB Data byte - LSDB | | | | | | |
| C | DB [31:24 | .] | | 0 | DB [23:16 | 6] | | DB [15:8] | | | | | DB [7:0] | | |

After each byte is received, the DACx3004W family acknowledges the byte by pulling the SDA line low during the high period of a single clock pulse, as shown in Figure 7-23. These four bytes and acknowledge cycles make up the 36 clock cycles required for a single update to occur. A valid I²C address byte selects the DACx3004W.

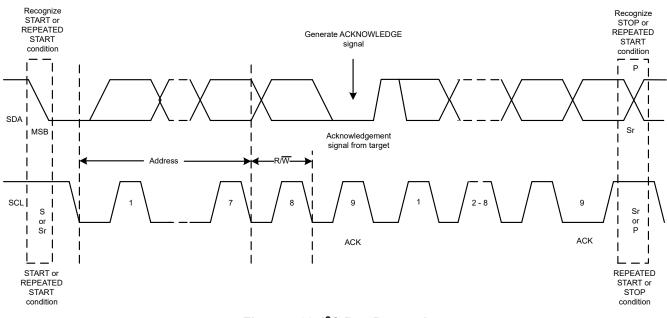


Figure 7-23. I²C Bus Protocol

The command byte sets the operating mode of the selected DACx3004W device. For a data update to occur when the operating mode is selected by this byte, the DACx3004W device must receive two data bytes: the most significant data byte (MSDB) and least significant data byte (LSDB). The DACx3004W device performs an update on the falling edge of the acknowledge signal that follows the LSDB.

When using fast mode (clock = 400 kHz), the maximum DAC update rate is limited to 10 kSPS. Using fast mode plus (clock = 1 MHz), the maximum DAC update rate is limited to 25 kSPS. When a stop condition is received, the DACx3004W device releases the l^2C bus and awaits a new start condition.



7.5.2.2.1 Address Byte

The address byte, as shown in Table 7-15, is the first byte received from the controller device following the start condition. The first four bits (MSBs) of the address are factory preset to 1001. The next three bits of the address are controlled by the A0 pin. The A0 pin input can be connected to VDD, AGND, SCL, or SDA. The A0 pin is sampled during the first byte of each data frame to determine the address. The device latches the value of the address pin, and consequently responds to that particular address according to Table 7-16.

| | | | | J. Audie33 | Dyte | | | | | | | |
|-------------------|-----|--------|-----|------------|------|----------------------------------|-----|--------|--|--|--|--|
| COMMENT | | MSB LS | | | | | | | | | | |
| _ | AD6 | AD5 | AD4 | AD3 | AD2 | AD1 | AD0 | R/W | | | | |
| General address | 1 | 0 | 0 | 1 | | See Table 7-16 et address col | | 0 or 1 | | | | |
| Broadcast address | 1 | 0 | 0 | 0 | 1 | 1 | 1 | 0 | | | | |

Table 7-15. Address Byte

| | Iuless Folliat |
|----------------|----------------|
| TARGET ADDRESS | A0 PIN |
| 000 | AGND |
| 001 | VDD |
| 010 | SDA |
| 011 | SCL |

Table 7-16. Address Format

The DACx3004W supports broadcast addressing, which is used for synchronously updating or powering down multiple DACx3004W devices. When the broadcast address is used, the DACx3004W responds regardless of the address pin state. Broadcast is supported only in write mode.

7.5.2.2.2 Command Byte

The *Register Names* table in the *Register Map* section lists the command byte in the ADDRESS column.



7.5.2.3 I²C Read Sequence

To read any register the following command sequence must be used:

- 1. Send a start or repeated start command with a target address and the R/W bit set to 0 for writing. The device acknowledges this event.
- 2. Send a command byte for the register to be read. The device acknowledges this event again.
- 3. Send a repeated start with the target address and the R/W bit set to 1 for reading. The device acknowledges this event.
- 4. The device writes the MSDB byte of the addressed register. The controller must acknowledge this byte.
- 5. Finally, the device writes out the LSDB of the register.

The broadcast address cannot be used for reading.

| s | MSB | | | R/W (0) | ACK | MSB | | LSB | ACK | Sr | MSB | | R/W (1) | ACK | MSB | | LSB | ACK | MSB | | LSB | ACK |
|---|--------|-----|-------|----------------|--------|------|-----|-----------------|--------|-----------------|--------------------------------------|---|------------|-----------------|-----|------|------------|-----|-----|--|-----|-----|
| | | | | BYTE .2.2.1 | | | | BYTE 5.2.2.2 | | Sr | Sr ADDRESS BYTE Section 7.5.2.2.1 | | | MSDB | | | LSDB | | 3 | | | |
| | From (| Con | troll | er | Target | From | Con | troller | Target | From Controller | | From Controller Target From Target Controller From Target | | From Target Cor | | rget | Controller | | | | | |

Table 7-17. Read Sequence

7.5.3 General-Purpose Input/Output (GPIO) Modes

Together with I²C and SPI, the DACx3004W also support a GPIO that can be configured in the NVM for multiple functions. This pin allows for updating the DAC output channels and reading status bits without using the programming interface, thus enabling processor-less operation. In the GPIO-CONFIG register, write 1 to the GPI-EN bit to set the GPIO pin as an input, or write 1 to the GPO-EN bit to set the pin as output. There are global and channel-specific functions mapped to the GPIO pin. For channel-specific functions, select the channels using the GPI-CH-SEL field in the GPIO-CONFIG register. Table 7-18 lists the functional options available for the GPIO as input and Table 7-19 lists the options for the GPIO as output. Some of the GP input operations are edge-triggered after the device boots up. After the power supply ramps up, the device registers the GPI level and executes the associated command. This feature allows the user to configure the initial output state at power-on. By default, the GPIO pin is not mapped to any operation. When the GPIO pin is mapped to a specific input function, the corresponding software bit functionality is disabled to avoid a race condition. When used as a RESET input, the GPIO pin must transmit an active-low pulse for triggering a device reset. All other constraints of the functions are applied to the GPIO-based trigger.

Note

Pull the GPIO pin to high or low when not used. When the GPIO pin is used as RESET, the configuration must be programmed into the NVM. Otherwise, the setting is cleared after the device resets.





| | | Table 7-18 | . General-Purpose Input | Function Map |) |
|-------------|------------|------------|--|----------------------|---|
| REGISTER | BIT FIELD | VALUE | CHANNELS | GPIO EDGE / LEVEL | FUNCTION |
| | | 0000 | All | Falling-edge | Trigger DEEP-SLEEP mode. |
| | | 0000 | All | Rising-edge | Bring the device out of deep-sleep. |
| | | 0010 | A 11 | Falling-edge | Trigger FAULT-DUMP |
| | | 0010 | All | Rising-edge | No effect |
| | | 0011 | | Falling-edge | IOUT power-down |
| | | 0011 | As per GPI-CH-SEL | Rising-edge | IOUT power-up |
| | | 0100 | As per GPI-CH-SEL | Falling-edge | VOUT power-down. Pulldown resistor as per the VOUT-PDN-X setting |
| | | | | Rising-edge | VOUT power-up |
| | | 0101 | All | Falling-edge | Trigger PROTECT function |
| | | 0101 | | Rising-edge | No effect |
| | | 0111 | All | Falling-edge | Trigger CLR function |
| | | | All | Rising-edge | No effect |
| | | | As per GPI-CH-SEL. Both | Falling-edge | Trigger LDAC function |
| GPIO-CONFIG | GPI-CONFIG | 1000 | the SYNC-CONFIG-X and the GPI-CH-SEL must be configured for every channel. | Rising-edge | No effect |
| | | 1001 | | Falling-edge | Stop function generation |
| | | 1001 | As per GPI-CH-SEL | Rising-edge | Start function generation |
| | | 1010 | | Falling-edge | Trigger margin-low |
| | | 1010 | As per GPI-CH-SEL | Rising-edge | Trigger margin-high |
| | | 1011 | All | Low pulse | Trigger device RESET. The RESET configuration must be programmed into the NVM. |
| | | | | Rising-edge | No effect |
| | | 1100 | A11 | Falling-edge | Allows NVM programming |
| | | 1100 | All | Rising-edge | Blocks NVM programming |
| | | | | Falling-edge | Allows register map update |
| | | 1101 | All | rising-edge | Blocks register map write except a write to the DEV-UNLOCK field through I ² C or SPI and to the RESET field through I ² C |
| | | Others | NA | NA | Not applicable |

Table 7-18. General-Purpose Input Function Map

Table 7-19. General-Purpose Output (STATUS) Function Map

| REGISTER | BIT FIELD | VALUE | FUNCTION |
|-------------|------------|--------|------------------------|
| | | 0001 | NVM-BUSY |
| | | 0100 | DAC-0-BUSY |
| | | 0100 | DAC-1-BUSY |
| | | 0101 | DAC-2-BUSY |
| | | 0110 | DAC-2-BUSY |
| GPIO-CONFIG | GPO-CONFIG | 1000 | WIN-CMP-0 |
| | | 1000 | WIN-CMP-0 |
| | | 1001 | WIN-CMP-2 |
| | | 1010 | WIN-CMP-2 WIN-CMP-3 |
| | | Others | |
| | | Others | Not applicable |



7.6 Register Map

| | | | MOST | SIGNIFICANT | DATA BYTE | (MSDB) | | | | | LEAST | SIGNIFICAN | T DATA BYTE | (LSDB) | | | |
|--|----------------------|-----------------------|--------------------------|------------------|-------------------------|-------------------|-------------------|------------------|---------------------------------------|-------------------|---------------------|------------------|--------------------|----------------------|-------------------|------------------|--|
| REGISTER ⁽¹⁾ ⁽²⁾ | BIT15 | BIT14 | BIT13 | BIT12 | BIT11 | BIT10 | BIT9 | BIT8 | BIT7 | BIT6 | BIT5 | BIT4 | BIT3 | BIT2 | BIT1 | BIT0 | |
| NOP | | | | | | | | N | OP | | | | | | | | |
| DAC-X-MARGIN- HIGH | | | | | | DAC-X-MA | RGIN-HIGH | | | | | × | | | | | |
| DAC-X-MARGIN- LOW | | | | | | DAC-X-MA | RGIN-LOW | | | | | | X | | | | |
| DAC-X-VOUT- CMP-CONFIG | | х | | | Vout-gain-> | (| | X CMP-X-O EN | | | | | CMP-X- OUT-EN | CMP-X-HIZ- IN-DIS | CMP-X-INV- EN | CMP-X-EN | |
| DAC-X-IOUT-MISC- CONFIG | | х | | | IOUT-X | -RANGE | 1 | | | | | х | | | | | |
| DAC-X-CMP- MODE-CONFIG | | | х | | CMP-X | -MODE | | | | | 2 | x | | | | | |
| DAC-X-FUNC- CONFIG | CLR-SEL-X | SYNC- CONFIG-X | BRD- CONFIG-X | | FUNC-GEN-CONFIG-BLOCK-X | | | | | | | | | | | | |
| DAC-X-DATA | | | | | | DAC-> | K-DATA | | | | | | | 2 | x | | |
| COMMON-CONFIG | WIN- LATCH-EN | DEV-LOCK | EE-READ- ADDR | EN-INT-REF | VOUT | -PDN-3 | IOUT-PDN-3 | VOUT | -PDN-2 | IOUT-PDN-2 | JT-PDN-2 VOUT-PDN-1 | | IOUT-PDN-1 | JT-PDN-1 VOUT-P | | IOUT-PDN-0 | |
| COMMON- TRIGGER | | DEV-U | NLOCK | | | RE | SET | | LDAC | CLR | X | FAULT- DUMP | PROTECT | READ-ONE- TRIG | NVM-PROG | NVM- RELOAD | |
| COMMON-DAC- TRIG | RST-CMP- FLAG-0 | TRIG-MAR- LO-0 | TRIG-MAR- HI-0 | START- FUNC-0 | RST-CMP- FLAG-1 | TRIG-MAR- LO-1 | TRIG-MAR- HI-1 | START- FUNC-1 | RST-CMP- FLAG-2 | TRIG-MAR- LO-2 | TRIG-MAR- HI-2 | START- FUNC-2 | RST-CMP- FLAG-3 | TRIG-MAR- LO-3 | TRIG-MAR- HI-3 | START- FUNC-3 | |
| GENERAL-STATUS | NVM-CRC- FAIL-INT | NVM-CRC- FAIL-USER | X | DAC- BUSY-3 | DAC- BUSY-2 | DAC- BUSY-1 | DAC- BUSY-0 | NVM-BUSY | | DEVICE-ID | | | | | | | |
| CMP-STATUS | | | | Х | | | | PROTECT- FLAG | WIN-CMP-3 WIN-CMP-2 WIN-CMP-1 WIN-CMP | | | WIN-CMP-0 | CMP- FLAG-3 | CMP- FLAG-2 | CMP- FLAG-1 | CMP- FLAG-0 | |
| GPIO-CONFIG | GF-EN | DEEP- SLEEP-EN | GPO-EN | | GPO-C | CONFIG | | | GPI-C | H-SEL | | | GPI-CONFIG GPI | | | | |
| DEVICE-MODE- CONFIG | RESE | RVED | DIS-MODE- IN | | RESERVED | | PROTEC | T-CONFIG | | RESERVED | | | | Х | | 1 | |
| INTERFACE- CONFIG | | Х | | TIMEOUT- EN | | Х | | EN-PMBUS | | | Х | | | FSDO-EN | X | SDO-EN | |
| SRAM-CONFIG | | | | > | (| | | | | | | SRAM | I-ADDR | | | | |
| SRAM-DATA | | SRAM-DATA | | | | | | | | | | | | | | | |
| DAC-X-DATA-8BIT | | | | DAC-X-D | ATA-8BIT | | | | | | | | х | | | | |
| BRDCAST-DATA | | | | | | BRDCA | ST-DATA | | | | | | | : | x | | |
| PMBUS-PAGE | | | PMBUS-PAGE NA | | | | | | | | | | | | | | |
| PMBUS-OP-CMD | | | PMBUS-OPERATION-CMD-X NA | | | | | | | | | | | | | | |
| PMBUS-CML | | | : | x | | | CML | x | | | | Ν | A | | | | |
| PMBUS-VERSION | | | | PMBUS- | /ERSON | | | | | | | Ν | A | | | | |

Table 7-20. Register Map

(1) The highlighted gray cells indicate the register bits or fields that are stored in the NVM.
 (2) X = Don't care.

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Table 7-21. Register Names

| I ² C/SPI ADDRESS | PMBUS PAGE ADDR | PMBUS REGISTER ADDR | REGISTER NAME | SECTION |
|------------------------------|-----------------|------------------------|------------------------|----------------|
| 00h | FFh | D0h | NOP | Section 7.6.1 |
| 01h | 00h | 25h | DAC-0-MARGIN-HIGH | Section 7.6.2 |
| 02h | 00h | 26h | DAC-0-MARGIN-LOW | Section 7.6.3 |
| 03h | FFh | D1h | DAC-0-VOUT-CMP-CONFIG | Section 7.6.4 |
| 04h | FFh | D2h | DAC-0-IOUT-MISC-CONFIG | Section 7.6.5 |
| 05h | FFh | D3h | DAC-0-CMP-MODE-CONFIG | Section 7.6.6 |
| 06h | FFh | D4h | DAC-0-FUNC-CONFIG | Section 7.6.7 |
| 07h | 01h | 25h | DAC-1-MARGIN-HIGH | Section 7.6.2 |
| 08h | 01h | 26h | DAC-1-MARGIN-LOW | Section 7.6.3 |
| 09h | FFh | D5h | DAC-1-VOUT-CMP-CONFIG | Section 7.6.4 |
| 0Ah | FFh | D6h | DAC-1-IOUT-MISC-CONFIG | Section 7.6.5 |
| 0Bh | FFh | D7h | DAC-1-CMP-MODE-CONFIG | Section 7.6.6 |
| 0Ch | FFh | D8h | DAC-1-FUNC-CONFIG | Section 7.6.7 |
| 0Dh | 02h | 25h | DAC-2-MARGIN-HIGH | Section 7.6.2 |
| 0Eh | 02h | 26h | DAC-2-MARGIN-LOW | Section 7.6.3 |
| 0Fh | FFh | D9h | DAC-2-VOUT-CMP-CONFIG | Section 7.6.4 |
| 10h | FFh | DAh | DAC-2-IOUT-MISC-CONFIG | Section 7.6.5 |
| 11h | FFh | DBh | DAC-2-CMP-MODE-CONFIG | Section 7.6.6 |
| 12h | FFh | DCh | DAC-2-FUNC-CONFIG | Section 7.6.7 |
| 13h | 03h | 25h | DAC-3-MARGIN-HIGH | Section 7.6.2 |
| 14h | 03h | 26h | DAC-3-MARGIN-LOW | Section 7.6.3 |
| 15h | FFh | DDh | DAC-3-VOUT-CMP-CONFIG | Section 7.6.4 |
| 16h | FFh | DEh | DAC-3-IOUT-MISC-CONFIG | Section 7.6.5 |
| 17h | FFh | DFh | DAC-3-CMP-MODE-CONFIG | Section 7.6.6 |
| 18h | FFh | E0h | DAC-3-FUNC-CONFIG | Section 7.6.7 |
| 19h | 00h | 21h | DAC-0-DATA | Section 7.6.8 |
| 1Ah | 01h | 21h | DAC-1-DATA | Section 7.6.8 |
| 1Bh | 02h | 21h | DAC-2-DATA | Section 7.6.8 |
| 1Ch | 03h | 21h | DAC-3-DATA | Section 7.6.8 |
| 1Fh | FFh | E3h | COMMON-CONFIG | Section 7.6.9 |
| 20h | FFh | E4h | COMMON-TRIGGER | Section 7.6.10 |
| 21h | FFh | E5h | COMMON-DAC-TRIG | Section 7.6.11 |

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Table 7-21. Register Names (continued)

| I ² C/SPI ADDRESS | PMBUS PAGE ADDR | PMBUS REGISTER ADDR | REGISTER NAME | SECTION |
|------------------------------|-----------------|------------------------|--------------------|----------------|
| 22h | FFh | E6h | GENERAL-STATUS | Section 7.6.12 |
| 23h | FFh | E7h | CMP-STATUS | Section 7.6.13 |
| 24h | FFh | E8h | GPIO-CONFIG | Section 7.6.14 |
| 25h | FFh | E9h | DEVICE-MODE-CONFIG | Section 7.6.15 |
| 26h | FFh | EAh | INTERFACE-CONFIG | Section 7.6.16 |
| 2Bh | FFh | EFh | SRAM-CONFIG | Section 7.6.17 |
| 2Ch | FFh | F0h | SRAM-DATA | Section 7.6.18 |
| 40h | NA | NA | DAC-0-DATA-8BIT | Section 7.6.19 |
| 41h | NA | NA | DAC-1-DATA-8BIT | Section 7.6.19 |
| 42h | NA | NA | DAC-2-DATA-8BIT | Section 7.6.19 |
| 43h | NA | NA | DAC-3-DATA-8BIT | Section 7.6.19 |
| 50h | FFh | F1h | BRDCAST-DATA | Section 7.6.20 |
| NA | All pages | 00h | PMBUS-PAGE | Section 7.6.21 |
| NA | 00h | 01h | PMBIS-OP-CMD-0 | Section 7.6.22 |
| NA | 01h | 01h | PMBUS-OP-CMD-1 | Section 7.6.22 |
| NA | 02h | 01h | PMBUS-OP-CMD-2 | Section 7.6.22 |
| NA | 03h | 01h | PMBUS-OP-CMD-3 | Section 7.6.22 |
| NA | All pages | 78h | PMBUS-CML | Section 7.6.23 |
| NA | All pages | 98h | PMBUS-VERSION | Section 7.6.24 |

Table 7-22. Access Type Codes

| Access Type | Code | Description |
|------------------------|------|--|
| Х | Х | Don't care |
| Read Type | | |
| R | R | Read |
| Write Type | - | |
| W | W | Write |
| Reset or Default Value | | |
| -n | | Value after reset or the default value |



7.6.1 NOP Register (address = 00h) [reset = 0000h]

PMBus page address = FFh, PMBus register address = D0h

| | Figure 7-24. NOP Register | | | | | | | | | | | | | | |
|----|---------------------------|----|----|----|----|---|----|----|---|---|---|---|---|---|---|
| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| | | | | | | | N | OP | | | | | | | |
| | | | | | | | R- | 0h | | | | | | | |

Table 7-23. NOP Register Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|-------|------|-------|--------------|
| 15-0 | NOP | R | 0000h | No operation |

7.6.2 DAC-X-MARGIN-HIGH Register (address = 01h, 07h, 0Dh, 13h) [reset = 0000h]

PMBus page address = 00h, 01h, 02h, 03h, PMBus register address = 25h

Figure 7-25. DAC-X-MARGIN-HIGH Register (X = 0, 1, 2, 3)

| 15 | 15 14 13 12 11 10 9 8 7 6 5 4 3 2 1 0 | | | | | | | | | | | 0 | | | |
|----------|---------------------------------------|--|--|--|-------------------|--|--|--|----|----|--|---|---|---|--|
| | | | | | X-MARG -X-MARG | | | | | | | | > | < | |
| R/W-000h | | | | | | | | | Х- | 0h | | | | | |

Table 7-24. DAC-X-MARGIN-HIGH Register Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|-------------------------|------|-------|---|
| 15-4 | DAC-X-MARGIN-HIGH[11:0] | R/W | 000h | Margin-high code for DAC output |
| | DAC-X-MARGIN-HIGH[9:0] | | | Data are in straight-binary format. MSB left-aligned. |
| | | | | Use the following bit-alignment: |
| | | | | DAC63004W VOUT: {DAC-X-MARGIN-HIGH[11:0]} DAC53004W VOUT: {DAC-X-MARGIN-HIGH[9:0], X, X} |
| | | | | X = Don't care bits. |
| 3-0 | x | Х | 0 | Don't care |

7.6.3 DAC-X-MARGIN-LOW Register (address = 02h, 08h, 0Eh, 14h) [reset = 0000h]

PMBus page address = 00h, 01h, 02h, 03h, PMBus register address = 26h

Figure 7-26. DAC-X-MARGIN-LOW Register (X = 0, 1, 2, 3)

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|----|----|----|----|--------------------|------|---|---|---|---|---|---|----|----|---|
| | | | | | -X-MARG -X-MARG | | | | | | | | > | < | |
| | | | | | R/W- | 000h | | | | | | | Х- | 0h | |

Table 7-25. DAC-X-MARGIN-LOW Register Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|------------------------|------|-------|---|
| 15-4 | DAC-X-MARGIN-LOW[11:0] | R/W | 000h | Margin-low code for DAC output |
| | DAC-X-MARGIN-LOW[9:0] | | | Data are in straight-binary format. MSB left-aligned. |
| | | | | Use the following bit-alignment: |
| | | | | DAC63004W VOUT: {DAC-X-MARGIN-LOW[11:0]} DAC53004W VOUT: {DAC-X-MARGIN-LOW[9:0], X, X} |
| | | | | X = Don't care bits. |
| 3-0 | x | Х | 0 | Don't care |



7.6.4 DAC-X-VOUT-CMP-CONFIG Register (address = 03h, 09h, 0Fh, 15h) [reset = 0000h]

PMBus page address = FFh, PMBus register address = D1h, D5h, D9h, DDh

| | | | Ilguie | ; 1-21. | DAU-/ | | 1-01011 | -001 | | egiste | i (x - 0 | , I , Z , J |) | | |
|----|------|----|--------|----------|-------|---|---------|------|---|--------|---------------------|---------------------------|--------------------------|----------------------|--------------|
| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| | Х | | VOL | JT-GAIN- | -X | | | Х | | | CMP- X-OD- EN | CMP- X-OUT- EN | CMP-X- HIZ-IN- DIS | CMP- X-INV- EN | CMP- X-EN |
| | X-0h | | F | R/W-0h | | | | X-0h | | | R/W-0h | R/W-0h | R/W-0h | R/W-0h | R/W-0h |

Figure 7-27. DAC-X-VOUT-CMP-CONFIG Register (X = 0, 1, 2, 3)

Table 7-26. DAC-X-VOUT-CMP-CONFIG Register Field Descriptions

| Bit | Field | Туре | Reset | Description |
|-------|------------------|------|-------|---|
| 15-13 | X | Х | 0h | Don't care |
| 12-10 | VOUT-GAIN-X | R/W | Oh | 000: Gain = 1x, external reference on VREF pin 001: Gain = 1x, VDD as reference 010: Gain = 1.5x, internal reference 011: Gain = 2x, internal reference 100: Gain = 3x, internal reference 101: Gain = 4x, internal reference Others: Invalid |
| 9-5 | x | Х | 0h | Don't care |
| 4 | CMP-X-OD-EN | R/W | 0 | 0: Set OUTx pin as push-pull 1: Set OUTx pin as open-drain in comparator mode (CMP-X-EN = 1 and CMP-X-OUT-EN = 1) |
| 3 | CMP-X-OUT-EN | R/W | 0 | 0: Generate comparator output but consume internally1: Bring comparator output to the respective OUTx pin |
| 2 | CMP-X-HIZ-IN-DIS | R/W | 0 | 0: FBx input has high-impedance. Input voltage range is limited. 1: FBx input is connected to resistor divider and has finite impedance. Input voltage range is same as full-scale. |
| 1 | CMP-X-INV-EN | R/W | 0 | 0: Don't invert the comparator output 1: Invert the comparator output |
| 0 | CMP-X-EN | R/W | 0 | 0: Disable comparator mode 1: Enable comparator mode. Current-output must be in power- down. Voltage-output mode must be enabled. |



7.6.5 DAC-X-IOUT-MISC-CONFIG Register (address = 04h, 0Ah, 10h, 16h) [reset = 0000h]

PMBus page address = FFh, PMBus register address = D2h, D6h, DAh, DEh

| | | | гıgui | e /-20 | . DAC-/ | V-IOU I | -141130- | CONFI | G Reg | ster (A | ν – υ, η, | ,∠, ა) | | | |
|----|------|----|-------|--------|---------|----------------|----------|-------|-------|---------|------------------|----------------|---|---|---|
| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| | Х | | | IOUT-R | ANGE-X | | | | | | Х | | | | |
| | X-0h | | | R/V | V-0h | | | | | | X-0h | | | | |

Figure 7-28. DAC-X-IOUT-MISC-CONFIG Register (X = 0, 1, 2, 3)

Table 7-27. DAC-X-IOUT-MISC-CONFIG Register Field Descriptions

| Bit | Field | Туре | Reset | Description |
|-------|--------------|------|-------|---|
| 15-13 | x | Х | 0h | Don't care |
| 12-9 | IOUT-RANGE-X | R/W | 0000 | 0000: 0 μA to 25 μA 0001: 0 μA to 50 μA 0010: 0 μA to 125 μA 0011: 0 μA to 250 μA 0100: 0 μA to -24 μA 0101: 0 μA to -48 μA 0110: 0 μA to -120 μA 0111: 0 μA to -240 μA 1000: -25 μA to +25 μA 1001: -50 μA to +50 μA 1010: -125 μA to +125 μA 1011: -250 μA to +250 μA 0thers: Invalid |
| 8-0 | x | Х | 000h | Don't care |

7.6.6 DAC-X-CMP-MODE-CONFIG Register (address = 05h, 0Bh, 11h, 17h) [reset = 0000h]

PMBus page address = FFh, PMBus register address = D3h, D7h, DBh, DFh

Figure 7-29. DAC-X-CMP-MODE-CONFIG Register (X = 0, 1, 2, 3)

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|----|----|----|-------|-------|---|---|---|---|----|----|---|---|---|---|
| | > | (| | CMP-X | -MODE | | | | |) | < | | | | |
| | X- | 0h | | R/V | V-0h | | | | | X- | 0h | | | | |

Table 7-28. DAC-X-CMP-MODE-CONFIG Register Field Descriptions

| Bit | Field | Туре | Reset | Description |
|-------|------------|------|-------|---|
| 15-12 | x | Х | 00h | Don't care |
| 11-10 | CMP-X-MODE | R/W | 00 | 00: No hysteresis or window function 01: Hysteresis provided using DAC-X-MARGIN-HIGH and DAC-X-MARGIN-LOW registers 10: Window comparator mode with DAC-X-MARGIN-HIGH and DAC-X-MARGIN-LOW registers setting window bounds 11: Invalid |
| 9-0 | x | Х | 000h | Don't care |



7.6.7 DAC-X-FUNC-CONFIG Register (address = 06h, 0Ch, 12h, 18h) [reset = 0000h]

PMBus page address = FFh, PMBus register address = D4h, D8h, DCh, E0h

Figure 7-30. DAC-X-FUNC-CONFIG Register (X = 0, 1, 2, 3)

| | | | | | | | | | • | | | | | | |
|-----------|-------------------|------------------|----|----|----|---|-----|--------|---------|--------|----|---|---|---|---|
| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| CLR-SEL-X | SYNC- CONFIG-X | BRD- CONFIG-X | | | | | FUI | NC-GEI | N-CONF | IG-BLC | CK | | | | |
| R/W-0h | R/W-0h | R/W-0h | | | | | | F | R/W-000 | h | | | | | |

Table 7-29. DAC-X-FUNC-CONFIG Register Field Descriptions

| Bit | Field | Туре | Reset | Description |
|-----|---------------|------|-------|--|
| 15 | CLR-SEL-X | R/W | 0 | 0: Clear DAC-X to zero-scale 1: Clear DAC-X to mid-scale |
| 14 | SYNC-CONFIG-X | R/W | 0 | 0: DAC-X output updates immediately after a write command 1: DAC-X output updates with LDAC pin falling-edge or when the LDAC bit in the COMMON-TRIGGER register is set to 1 |
| 13 | BRD-CONFIG-X | R/W | 0 | 0: Don't update DAC-X with broadcast command 1: Update DAC-X with broadcast command |

Table 7-30. Linear-Slew Mode: FUNC-GEN-CONFIG-BLOCK Field Descriptions

| Bit | Field | Туре | Reset | Description |
|-------|---------------|------|-------|--|
| 12-11 | PHASE-SEL-X | R/W | 0 | 00: 0° 01: 120° 10: 240° 11: 90° |
| 10-8 | FUNC-CONFIG-X | R/W | 0 | 000: Triangular wave 001: Sawtooth wave 010: Inverse sawtooth wave 100: Sine wave 111: Disable function generation Others: Invalid |
| 7 | LOG-SLEW-EN-X | R/W | 0 | 0: Enable linear slew |
| 6-4 | CODE-STEP-X | R/W | 0 | CODE-STEP for linear slew mode: 000: 1-LSB 001: 2-LSB 010: 3-LSB 011: 4-LSB 100: 6-LSB 101: 8-LSB 110: 16-LSB 111: 32-LSB |
| 3-0 | SLEW-RATE-X | R/W | 0 | SLEW-RATE for linear slew mode: 0000: No slew for margin-high and margin-low. Invalid for waveform generation. 0001: 4 µs/step 0010: 8 µs/step 0011: 12 µs/step 0100: 18 µs/step 0101: 27.04 µs/step 0111: 60.72 µs/step 0100: 91.12 µs/step 1001: 136.72 µs/step 1001: 239.2 µs/step 1011: 418.64 µs/step 1100: 732.56 µs/step 1101: 1282 µs/step 1111: 5127.92 µs/step |



| _ | | | | SEN-CONFIG-BLOCK Field Descriptions |
|--------|---------------|------|-------|---|
| Bit | Field | Туре | Reset | Description |
| 12-11 | PHASE-SEL-X | R/W | 0 | 00: 0° 01: 120° 10: 240° 11: 90° |
| 10 - 8 | FUNC-CONFIG-X | R/W | 0 | 000: Triangular wave 001: Sawtooth wave 010: Inverse sawtooth wave 100: Sine wave 111: Disable function generation Others: Invalid |
| 7 | LOG-SLEW-EN-X | R/W | 0 | 1: Enable logarithmic slew. In logarithmic slew mode, the DAC output moves from the DAC- X-MARGIN-LOW code to the DAC-X-MARGIN-HIGH code, or vice versa, in 3.125% steps. When slewing in the positive direction, the next step is (1 + 0.03125) times the current step. When slewing in the negative direction, the next step is (1 – 0.03125) times the current step. When DAC-X-MARGIN-LOW is 0, the slew starts from code 1. The time interval for each step is defined by RISE-SLEW-X and FALL-SLEW-X. |
| 6-4 | RISE-SLEW-X | R/W | 0 | SLEW-RATE for logarithmic slew mode (DAC-X-MARGIN-LOW to DAC-X-MARGIN-HIGH): 000: 4 µs/step 001: 12 µs/step 010: 27.04 µs/step 011: 60.72 µs/step 100: 136.72 µs/step 101: 418.64 µs/step 110: 1282 µs/step 111: 5127.92 µs/step |
| 3-1 | FALL-SLEW-X | R/W | 0 | SLEW-RATE for logarithmic slew mode (DAC-X-MARGIN-HIGH to DAC-X-MARGIN-LOW): 000: 4 µs/step 001: 12 µs/step 010: 27.04 µs/step 011: 60.72 µs/step 100: 136.72 µs/step 101: 418.64 µs/step 110: 1282 µs/step 111: 5127.92 µs/step |
| 0 | X | X | 0 | Don't care |

Table 7-31. Logarithmic-Slew Mode: FUNC-GEN-CONFIG-BLOCK Field Descriptions



7.6.8 DAC-X-DATA Register (address = 19h, 1Ah, 1Bh, 1Ch) [reset = 0000h]

PMBus page address = 00h, 01h, 02h, 03h, PMBus register address = 21h

Figure 7-31. DAC-X-DATA Register (X = 0, 1, 2, 3)

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|-------------------------------------|----|----|----|----|---|---|---|---|---|---|----|----|---|---|
| | DAC-X-DATA[11:0] DAC-X-DATA[9:0] | | | | | | | | | | | > | < | | |
| | R/W-000h | | | | | | | | | | | Х- | 0h | | |

Table 7-32. DAC-X-DATA Register Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|-------------------------------------|------|-------|---|
| 15-4 | DAC-X-DATA[11:0] DAC-X-DATA[9:0] | R/W | 000h | Data for DAC output Data are in straight-binary format. MSB left-aligned. Use the following bit-alignment: DAC63004W VOUT: {DAC-X-DATA[11:0]} DAC53004W VOUT: {DAC-X-DATA[9:0], X, X} X = Don't care bits. |
| 3-0 | X | Х | 0h | Don't care |

7.6.9 COMMON-CONFIG Register (address = 1Fh) [reset = 0FFFh]

PMBus page address = FFh, PMBus register address = E3h

Figure 7-32. COMMON-CONFIG Register

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----------------------|--------------|------------------|----------------|--------|-------|----------------|--------|------|----------------|-------|-------|----------------|--------|-------|----------------|
| WIN- LATCH- EN | DEV- LOCK | EE-READ- ADDR | EN-INT- REF | VOUT-F | PDN-3 | IOUT- PDN-3 | VOUT-F | DN-2 | IOUT- PDN-2 | VOUT- | PDN-1 | IOUT- PDN-1 | VOUT-F | PDN-0 | IOUT- PDN-0 |
| R/W-0h | R/W-0h | R/W-0h | R/W-0h | R/W- | -11b | R/W-1b | R/W- | 11b | R/W-1b | R/W | -11b | R/W-1b | R/W- | 11b | R/W-1b |

Table 7-33. COMMON-CONFIG Register Field Descriptions

| Bit | Field | Туре | Reset | Description |
|-------------------------|--------------|------|-------|--|
| 15 | WIN-LATCH-EN | R/W | 0 | 0: Non-latching window-comparator output 1: Latching window-comparator output |
| 14 | DEV-LOCK | R/W | 0 | 0: Device not locked. 1: Device locked, the device locks all the registers. To set this bit back to 0 (unlock device), write to the unlock code to the DEV- UNLOCK field in the COMMON-TRIGGER register first, followed by a write to the DEV-LOCK bit as 0. |
| 13 | EE-READ-ADDR | R/W | 0 | 0: Fault-dump read enable at address 0x00 1: Fault-dump read enable at address 0x01 |
| 12 | EN-INT-REF | R/W | 0 | 0: Disable internal reference. 1: Enable internal reference. This bit must be set before using internal reference gain settings. |
| 11-10, 8-7, 5-4, 2-1 | VOUT-PDN-X | R/W | 11 | 00: Power-up VOUT-X 01: Power-down VOUT-X with 10 KΩ to AGND 10: Power-down VOUT-X with 100 KΩ to AGND 11: Power-down VOUT-X with Hi-Z to AGND |
| 9, 6, 3, 0 | IOUT-PDN-X | R/W | 1 | 0: Power-up IOUT-X 1: Power-down IOUT-X |



7.6.10 COMMON-TRIGGER Register (address = 20h) [reset = 0000h]

PMBus page address = FFh, PMBus register address = E4h

Figure 7-33. COMMON-TRIGGER Register

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|--------|-------|----|----|-----|------|---|--------|--------|------|----------------|---------|-----------------------|--------------|----------------|
| | DEV-UI | NLOCK | | | RES | SET | | LDAC | CLR | Х | FAULT- DUMP | PROTECT | READ- ONE- TRIG | NVM- PROG | NVM- RELOAD |
| | R/W | /-0h | | | R/W | /-0h | | R/W-0h | R/W-0h | X-0h | R/W-0h | R/W-0h | R/W-0h | R/W-0h | R/W-0h |

Table 7-34. COMMON-TRIGGER Register Field Descriptions

| Bit | Field | Туре | Reset | Description |
|--------|---------------|------|-------|---|
| 15-12 | DEV-UNLOCK | R/W | 0000 | 0101: Device unlocking password. To unlock device, write this unlock password first, followed by a write 0 to the DEV-LOCK bit in the COMMON-CONFIG register. Others: Don't care |
| 11 - 8 | RESET | W | 0000 | 1010: POR reset triggered. This bit self-resets. Others: Don't care |
| 7 | LDAC | R/W | 0 | 0: LDAC operation not triggered 1: LDAC operation triggered if the respective SYNC-CONFIG-X bit in the DAC-X-FUNC-CONFIG register is 1. This bit self-resets. |
| 6 | CLR | R/W | 0 | 0: DAC registers and outputs unaffected 1: DAC registers and outputs set to zero-code or mid-code based on the respective CLR-SEL-X bit in the DAC-X-FUNC-CONFIG register. This bit self-resets. |
| 5 | X | Х | 0 | Don't care |
| 4 | FAULT-DUMP | R/W | 0 | 0: Fault-dump is not triggered 1: Triggers fault-dump sequence. This bit self-resets. |
| 3 | PROTECT | R/W | 0 | 0: PROTECT function not triggered 1: Trigger PROTECT function. This bit is self-resetting. |
| 2 | READ-ONE-TRIG | R/W | 0 | 0: Fault-dump read not triggered 1: Read one row of NVM for fault-dump. This bit self-resets. |
| 1 | NVM-PROG | R/W | 0 | 0: NVM write not triggered 1: NVM write triggered. This bit self-resets. |
| 0 | NVM-RELOAD | R/W | 0 | 0: NVM reload not triggered 1: Reload data from NVM to register map. This bit self-resets. |



7.6.11 COMMON-DAC-TRIG Register (address = 21h) [reset = 0000h]

PMBus page address = FFh, PMBus register address = E5h

Figure 7-34. COMMON-DAC-TRIG Register

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|--------------------------|-----------------------|-----------------------|------------------|--------------------------|-----------------------|-----------------------|------------------|--------------------------|-----------------------|-----------------------|------------------|------|-----------------------|-----------------------|------------------|
| RESET- CMP- FLAG-0 | TRIG- MAR- LO-0 | TRIG- MAR- HI-0 | START- FUNC-0 | RESET- CMP- FLAG-1 | TRIG- MAR- LO-1 | TRIG- MAR- HI-1 | START- FUNC-1 | RESET- CMP- FLAG-2 | TRIG- MAR- LO-2 | TRIG- MAR- HI-2 | START- FUNC-2 | | TRIG- MAR- LO-3 | TRIG- MAR- HI-3 | START- FUNC-3 |
| W-0h | W-0h | W-0h | R/W-0h | W-0h | W-0h | W-0h | R/W-0h | W-0h | W-0h | W-0h | R/W-0h | W-0h | W-0h | W-0h | R/W-0h |

Table 7-35. COMMON-DAC-TRIG Register Field Descriptions

| Bit | Field | Туре | Reset | Description |
|-----------------|------------------|------|-------|---|
| 15, 11, 7, 3 | RESET-CMP-FLAG-X | W | 0 | 0: Latching-comparator output unaffected 1: Reset latching-comparator and window-comparator output. This bit self-resets. |
| 14, 10, 6, 2 | TRIG-MAR-LO-X | W | 0 | 0: Don't care 1: Trigger margin-low command. This bit self-resets. |
| 13, 9, 5, 1 | TRIG-MAR-HI-X | W | 0 | 0: Don't care 1: Trigger margin-high command. This bit self-resets. |
| 12, 8, 4, 0 | START-FUNC-X | R/W | 0 | 0: Stop function generation 1: Start function generation as per FUNC-GEN-CONFIG-X in the DAC-X-FUNC-CONFIG register. |



7.6.12 GENERAL-STATUS Register (address = 22h) [reset = 00h, DEVICE-ID, VERSION-ID]

PMBus page address = FFh, PMBus register address = E6h

Figure 7-35. GENERAL-STATUS Register

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|--------------------------|-------------------------------|------|----------------|----------------|----------------|----------------|------|---|---|------|-------|---|---|-------|-------|
| NVM- CRC- FAIL-INT | NVM- CRC- FAIL- USER | x | DAC-3- BUSY | DAC-2- BUSY | DAC-1- BUSY | DAC-0- BUSY | x | | | DEVI | CE-ID | | | VERSI | ON-ID |
| R-0h | R-0h | R-0h | R-0h | R-0h | R-0h | R-0h | X-0h | | | F | र | | | R- | 0h |

| Bit | Field | Туре | Reset | Description |
|-----|-------------------|------|----------------------------------|---|
| 15 | NVM-CRC-FAIL-INT | R | 0 | 0: No CRC error in OTP 1: Indicates a failure in OTP loading. A software reset or power-cycle can bring the device out of this condition in case of temporary failure. |
| 14 | NVM-CRC-FAIL-USER | R | 0 | 0: No CRC error in NVM loading 1: Indicates a failure in NVM loading. The register settings are corrupted. The device allows all operations during this error condition. Reprogram the NVM to get original state. A software reset brings the device out of this temporary error condition. |
| 13 | X | R | 0 | Don't care |
| 12 | DAC-3-BUSY | R | 0 | 0: DAC-3 channel can accept commands 1: DAC-3 channel does not accept commands |
| 11 | DAC-2-BUSY | R | 0 | 0: DAC-2 channel can accept commands 1: DAC-2 channel does not accept commands |
| 10 | DAC-1-BUSY | R | 0 | 0: DAC-1 channel can accept commands 1: DAC-1 channel does not accept commands |
| 9 | DAC-0-BUSY | R | 0 | 0: DAC-0 channel can accept commands 1: DAC-0 channel does not accept commands |
| 8 | X | R | 0 | Don't care |
| 7-2 | DEVICE-ID | R | DAC53004W: 05h DAC63004W: 04h | Device identifier |
| 1-0 | VERSION-ID | R | 00 | Version identifier |

Table 7-36. GENERAL-STATUS Register Field Descriptions

7.6.13 CMP-STATUS Register (address = 23h) [reset = 0000h]

PMBus page address = FFh, PMBus register address = E7h

| | Figure 7-36. CMP-STATUS Register | | | | | | | | | | | | | | |
|----|----------------------------------|----|------|----|----|---|------------------|---------------|---------------|---------------|---------------|--------------------|--------------------|------|--------------------|
| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| | | | Х | | | | PROTECT- FLAG | WIN- CMP-3 | WIN- CMP-2 | WIN- CMP-1 | WIN- CMP-0 | CMP- FLAG- 3 | CMP- FLAG- 2 | | CMP- FLAG- 0 |
| | | | X-0h | | | | R-0h | R-0h | R-0h | R-0h | R-0h | R-0h | R-0h | R-0h | R-0h |

Table 7-37. CMP-STATUS Register Field Descriptions

| Bit | Field | Туре | Reset | Description | | | | | | | | | |
|------------|--------------|------|-------|---|--|--|--|--|--|--|--|--|--|
| 15-9 | x | х | 0 | Don't care | | | | | | | | | |
| 8 | PROTECT-FLAG | R | 0 | 0: PROTECT operation not triggered.1: PROTECT function is completed or in progress. This bit resets to 0 when read. | | | | | | | | | |
| 7, 6, 5, 4 | WIN-CMP-X | R | 0 | Window comparator output from respective channels. The output is latched or unlatched based on the WINDOW-LATCH-EN setting in the COMMON-CONFIG register. | | | | | | | | | |
| 3, 2, 1, 0 | CMP-FLAG-X | R | 0 | Synchronized comparator output from respective channels. | | | | | | | | | |

7.6.14 GPIO-CONFIG Register (address = 24h) [reset = 0000h]

PMBus page address = FFh, PMBus register address = E8h

Figure 7-37. GPIO-CONFIG Register

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|--------|-----------------------|--------|----|--------|-------|---|---|-------|-------|---|---|-------|-------|---|--------|
| GF-EN | DEEP- SLEEP- EN | GPO-EN | | GPO-CO | ONFIG | | | GPI-C | H-SEL | | | GPI-C | ONFIG | | GPI-EN |
| R/W-0h | R/W-0h | R/W-0h | | R/W- | -0h | | | R/V | V-0h | | | R/V | V-0h | | R/W-0h |

Table 7-38. GPIO-CONFIG Register Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|---------------|------|-------|--|
| 15 | GF-EN | R/W | 0 | 0: Glitch filter disabled for GP input. This setting provides faster response. 1: Glitch filter enabled for GP input. This setting introduces additional propagation delay but provides robustness. |
| 14 | DEEP-SLEEP-EN | R/W | 0 | 0: Deep-sleep mode disabled 1: Deep-sleep mode enabled for GP input |
| 13 | GPO-EN | R/W | 0 | 0: Disable output mode for GPIO pin 1: Enable output mode for GPIO pin |
| 12-9 | GPO-CONFIG | R/W | 0000 | STATUS function setting. The GPIO pin is mapped to thefollowing register bits as output:0001: NVM-BUSY0100: DAC-0-BUSY0101: DAC-1-BUSY0111: DAC-2-BUSY0111: DAC-3-BUSY1000: WIN-CMP-01001: WIN-CMP-11010: WIN-CMP-21011:WIN-CMP-3Others: Invalid |





Bit Field Reset Description Туре R/W 8-5 GPI-CH-SEL 0000 Each bit corresponds to a DAC channel. 0b is *disabled* and 1b is enabled GPI-CH-SEL[0]: Channel 0 GPI-CH-SEL[1]: Channel 1 GPI-CH-SEL[2]: Channel 2 GPI-CH-SEL[3]: Channel 3 Example: when GPI-CH-SEL is 0101, both channel-0 and channel-2 are enabled and both channel-1 and channel-3 are disabled. R/W 0000 **GPI-CONFIG** GPIO pin input configuration. Global settings act on the 4-1 entire device. Channel-specific settings depend on the channel selection by the GPI-CH-SEL bits: 0000: DEEP-SLEEP (global). GPIO falling-edge triggers deepsleep mode, GPIO rising-edge takes the device out of deep-sleep mode. 0010: FAULT-DUMP (global). GPIO falling-edge triggers faultdump, GPIO = 1 has no effect. 0011: IOUT power-up, down (channel-specific). GPIO falling-edge triggers power-down, GPIO rising-edge triggers power-up. 0100: VOUT power-up/down (channel-specific). The output load is as per the VOUT-PDN-X setting. GPIO falling-edge triggers power-down, GPIO rising-edge triggers power-up. 0101: PROTECT input (global), GPIO falling-edge asserts PROTECT function, GPIO = 1 has no effect. 0111: $\overline{\text{CLR}}$ input (global). GPIO = 0 asserts $\overline{\text{CLR}}$ function, GPIO = 1 has no effect. 1000: LDAC input (channel-specific). GPIO falling-edge asserts LDAC function, GPIO = 1 has no effect. Both the SYNC-CONFIG-X and the GPI-CH-SEL must be configured for every channel. 1001: Start, stop function generation (channel-specific). GPIO falling-edge stops function generation. GPIO rising-edge starts function generation. 1010: Trigger margin-high, low (channel-specific). GPIO fallingedge triggers margin-low. GPIO rising-edge triggers margin-high. 1011: RESET input (global). The falling-edge of the GPIO pin asserts the RESET function. The RESET input must be a pulse. The GPIO rising-edge brings the device out of reset. The RESET configuration must be programmed into the NVM. Otherwise, the setting is cleared after the device reset. 1100: NVM write-protection (global). GPIO falling-edge allows NVM programming. GPIO rising-edge blocks NVM programming. 1101: Register-map lock (global). GPIO falling-edge allows update to the register map. GPIO rising-edge blocks any register map update except a write to the DEV-UNLOCK field through I²C or SPI and to the RESET field through I²C. Others: Not applicable R/W 0 GPI-EN n 0: Disable input mode for GPIO pin 1: Enable input mode for GPIO pin

Table 7-38. GPIO-CONFIG Register Field Descriptions (continued)



7.6.15 DEVICE-MODE-CONFIG Register (address = 25h) [reset = 0000h]

PMBus page address = FFh, PMBus register address = E9h

Figure 7-38. DEVICE-MODE-CONFIG Register

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|------|------|-----------------|----|--------|----|-------------|---------------|---|--------|----|---|---|------|---|---|
| RESE | RVED | DIS- MODE-IN | RE | SERVED |) | PROT CON | TECT- IFIG | R | ESERVE | ED | | | х | | |
| R/W | /-0h | R/W-0h | I | R/W-0h | | R/W | /-0h | | R/W-0h | | | | X-0h | | |

Table 7-39. DEVICE-MODE-CONFIG Register Field Descriptions

| Bit | Field | Туре | Reset | Description |
|-------|----------------|------|-------|---|
| 15-14 | RESERVED | R/W | 00 | Always write 0b00 |
| 13 | DIS-MODE-IN | R/W | 0 | Write 1 to this bit for low-power consumption. |
| 12-10 | RESERVED | R/W | 0 | Always write 0b000 |
| 9-8 | PROTECT-CONFIG | R/W | 00 | 00: Switch to Hi-Z power-down (no slew) 01: Switch to DAC code stored in NVM (no slew) and then switch to Hi-Z power-down 10: Slew to margin-low code and then switch to Hi-Z power-down 11: Slew to margin-high code and then switch to Hi-Z power-down |
| 7-5 | RESERVED | R/W | 0 | Always write 0b000 |
| 4-0 | X | R/W | 00h | Don't care |

7.6.16 INTERFACE-CONFIG Register (address = 26h) [reset = 0000h]

Figure 7-39. INTERFACE-CONFIG Register

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|------|----|----------------|----|------|---|----------|---|---|------|---|---|-------------|------|------------|
| | Х | | TIMEOUT- EN | | Х | | EN-PMBUS | | | Х | | | FSDO- EN | Х | SDO- EN |
| | X-0h | | R/W-0h | | X-0h | | R/W-0h | | | X-0h | | | R/W-0h | X-0h | R/W-0h |

Table 7-40. INTERFACE-CONFIG Register Field Descriptions

| Bit | Field | Туре | Reset | Description |
|-------|------------|------|-------|---|
| 15-13 | X | X | 0h | Don't care |
| 12 | TIMEOUT-EN | R/W | 0 | 0: I ² C timeout disabled 1: I ² C timeout enabled |
| 11-9 | X | X | 0h | Don't care |
| 8 | EN-PMBUS | R/W | 0 | 0: PMBus disabled 1: Enable PMBus |
| 7-3 | X | X | 00h | Don't care |
| 2 | FSDO-EN | R/W | 0 | 0: Fast SDO (FSDO) disabled 1: Fast SDO enabled |
| 1 | X | X | 0 | Don't care |
| 0 | SDO-EN | R/W | 0 | 0: SDO disabled 1: SDO enabled on GPIO pin |



7.6.17 SRAM-CONFIG Register (address = 2Bh) [reset = 0000h]

PMBus page address = FFh, PMBus register address = EFh

Figure 7-40. SRAM-CONFIG Register

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|----|----|-------|----|----|---|---|---|---|---|-----|--------|---|---|---|
| | | | Х | | | | | | | | SRA | M-ADDR | | | |
| | | | X-00h | | | | | | | | R/\ | N-00h | | | |

Table 7-41. SRAM-CONFIG Register Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|-----------|------|-------|--|
| 15-8 | x | Х | 00h | Don't care |
| 7-0 | SRAM-ADDR | R/W | | 8-bit SRAM address. Writing to this register field configures the SRAM address to be accessed next. This address automatically increments after a write to the SRAM. |

7.6.18 SRAM-DATA Register (address = 2Ch) [reset = 0000h]

PMBus page address = FFh, PMBus register address = F0h

Figure 7-41. SRAM-DATA Register

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|-----------|----|----|----|----|---|---------|-----|---|---|---|---|---|---|---|
| | SRAM-DATA | | | | | | | | | | | | | | |
| | | | | | | I | R/W-000 | 00h | | | | | | | |

Table 7-42. SRAM-DATA Register Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|-----------|------|-------|--|
| 15-0 | SRAM-DATA | R/W | | 16-bit SRAM data. Data are written to or read from the address configured in the SRAM-CONFIG register. |



7.6.19 DAC-X-DATA-8BIT Register (address = 40h, 41h, 42h, 43h) [reset = 0000h]

PMBus page address = Not applicable, PMBus register address = Not applicable

Figure 7-42. DAC-X-DATA-8BIT Register

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|----|-----|-----------|----------|----|---|---|---|---|---|---|------|---|---|---|
| | | DAC | -X-DATA-8 | BIT[7:0] | | | | | | | | х | | | |
| | | | R/W-00 | า | | | | | | | Х | -00h | | | |

Table 7-43. DAC-X-DATA-8BIT Register Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|----------------------|------|-------|--|
| 15-8 | DAC-X-DATA-8BIT[7:0] | R/W | | 8-bit data for current output. This register provides faster update rate in the I ² C mode. Data are in straight-binary format. |
| 7-0 | х | Х | 00h | Not applicable |

7.6.20 BRDCAST-DATA Register (address = 50h) [reset = 0000h]

PMBus page address = FFh, PMBus register address = F1h

Figure 7-43. BRDCAST-DATA Register

| 15 | 14 | 13 12 11 10 9 8 7 6 5 4 3 2 1 | | | | | | | | | | 0 | | |
|----|----------|-------------------------------|--|--|--------------------|--|--|--|--|--|--|-----|----|--|
| | | | | | AST-DAT AST-DAT | | | | | | | х | | |
| | R/W-000h | | | | | | | | | | | X-0 |)h | |

Table 7-44. BRDCAST-DATA Register Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|---|------|-------|---|
| 15-4 | BRDCAST-DATA[11:0] BRDCAST-DATA[9:0] | R/W | 000h | Broadcast code for all DAC channels Data are in straight-binary format. MSB left-aligned. Use the following bit-alignment: DAC63004W VOUT: {BRDCAST-DATA[11:0]} DAC53004W VOUT: {BRDCAST-DATA[9:0], X, X} X = Don't care bits. The BRD-CONFIG-X bit in the DAC-X-FUNC-CONFIG register must be enabled for the respective channels. |
| 3-0 | x | Х | 0h | Don't care. |

7.6.21 PMBUS-PAGE Register [reset = 0300h]

PMBus page address = X, PMBus register address = 00h

Figure 7-44. PMBUS-PAGE Register

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|----|----|-------|--------|----|---|---|---|---|---|-----|-----|---|---|---|
| | | | PMBUS | S-PAGE | | | | | | | > | × | | | |
| | | | R/W | -03h | | | | | | | X-0 | 00h | | | |

Table 7-45. PMBUS-PAGE Register Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|------------|------|-------|--|
| 15-8 | PMBUS-PAGE | R/W | | 8-bit PMBus page address as specified in the <i>Register Names</i> table in the <i>Register Map</i> section. |
| 7-0 | x | Х | 00h | Not applicable |



7.6.22 PMBUS-OP-CMD-X Register [reset = 0000h]

PMBus page address = 00h, 01h, 02h, 03h, PMBus register address = 01h

Figure 7-45. PMBUS-OP-CMD-X Register (X = 0, 1, 2, 3)

| | | | | • | | | | | • | • | | , | | | |
|----|----|------|---------|---------|-------|---|---|---|---|---|-----|-----|---|---|---|
| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| | | PMBU | IS-OPER | ATION-0 | CMD-X | | | | | | > | < | | | |
| | | | R/W | -00h | | | | | | | X-0 |)0h | | | |

Table 7-46. PMBUS-OP-CMD-X Register Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|-----------------------|------|-------|---|
| 15-8 | PMBUS-OPERATION-CMD-X | R/W | 00h | PMBus operation commands: 00h: Turn off 80h: Turn on A4h: Margin high, DAC output margins high to DAC-X-MARGIN- HIGH code 94h: Margin low, DAC output margins low to DAC-X-MARGIN- LOW code |
| 7-0 | x | Х | 00h | Not applicable |

7.6.23 PMBUS-CML Register [reset = 0000h]

PMBus page address = X, PMBus register address = 78h

Figure 7-46. PMBUS-CML Register

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|----|-----|-----|----|----|--------|------|---|---|---|-----|-----|---|---|---|
| | |) | x | | | CML | Х | | | | N | /A | | | |
| | | X-(| 00h | | | R/W-0h | X-0h | | | | X-0 |)0h | | | |

Table 7-47. PMBUS-CML Register Field Descriptions

| | | | | / / |
|-------|-------|------|-------|--|
| Bit | Field | Туре | Reset | Description |
| 15-10 | X | Х | 00h | Don't care |
| 9 | CML | R/W | 0 | 0: No communication fault 1: PMBus communication fault for write with incorrect number of clocks, read before write command, invalid command address, and invalid or unsupported data value; reset this bit by writing 1. |
| 8 | X | X | 0h | Don't care |
| 7-0 | x | Х | 00h | Not applicable |

7.6.24 PMBUS-VERSION Register [reset = 2200h]

PMBus page address = X, PMBus register address =98h

Figure 7-47. PMBUS-VERSION Register

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----|----|----|---------|--------|----|---|---|---|---|---|-----|-----|---|---|---|
| | | | PMBUS-\ | /ERSIO | N | | | | | | > | (| | | |
| | | | R-2 | 22h | | | | | | | X-0 | 00h | | | |

Table 7-48. PMBUS-VERSION Register Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|---------------|------|-------|----------------|
| 15-8 | PMBUS-VERSION | R | 22h | PMBus version |
| 7-0 | х | х | 00h | Not applicable |



8 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

8.1 Application Information

The DACx3004W are quad-channel buffered, force-sense output, voltage-output and current-output smart DACs that include an NVM and internal reference, and are available in a tiny 1.75-mm × 1.75-mm DSBGA package. The external reference must not exceed V_{DD} , either during transient or steady-state conditions. For the best Hi-Z output performance, use a pullup resistor on the VREF pin to VDD. In case the VDD pin remains floating during the off condition, place a 100-k Ω resistor to AGND for proper detection of the VDD pin *off* condition. All the digital outputs are open drain; use external pullup resistors on these pins. The interface protocol is detected at power-on, and the device locks to the protocol as long as V_{DD} is on. In I²C mode, when allocating the I²C addresses in the system, also consider the broadcast address. I²C timeout can be enabled for robustness. SPI mode is three-wire by default. Configure the GPIO pin as SDO in the NVM for SPI readback capability. The SPI clock speed in readback mode is slower than in write mode. Power-down mode sets the DAC outputs in Hi-Z by default. Change the configuration appropriately for different power-down settings. The DAC channels can also power-up with a programmed DAC code in the NVM.

8.2 Typical Application

The DACx3004W can be used as a programmable current source using an external MOSFET for current values greater than 250 μ A. The force-sense outputs of DACx3004W can be used to compensate for the gate-source voltage drop caused by temperature, drain current, and aging of the MOSFET. The GPIO pin can be used to switch the output current on or off without the need for run-time software. The slew between the on and off values can be programmed. Figure 8-1 shows how the DACx3004W is used as a programmable current source. A resistor, R_{SET}, connected to the source of the MOSFET sets the output current range. This circuit can be used in optical modules that require a high current output with a small size.

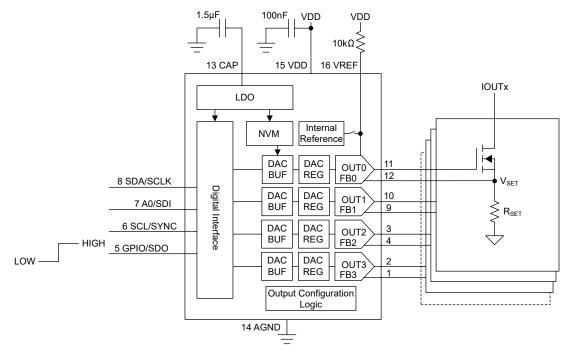


Figure 8-1. Current Source



8.2.1 Design Requirements

| Table 0-1. Design Farameters | | | | | | | |
|------------------------------|----------------|--|--|--|--|--|--|
| PARAMETER | VALUE | | | | | | |
| Current output range | 0 mA to 200 mA | | | | | | |
| DAC range | 0 V to 0.6 V | | | | | | |
| R _{SET} | 3 Ω | | | | | | |

Table 8-1. Design Parameters

8.2.2 Detailed Design Procedure

 V_{SET} is controlled by the DACx3004W to adjust the current output. R_{SET} sets the output range of the current source. Choose a small V_{SET} so that the power dissipation across R_{SET} is minimum. Equation 10 calculates R_{SET} .

$$R_{SET} = \frac{V_{SET}}{I_{OUT}}$$
(10)

A 0.6-V max V_{SET} is used in this example. Equation 11 shows that R_{SET} is calculated to be 3 Ω . Choose an R_{SET} with a power rating of at least 120 mW.

$$R_{SET} = \frac{0.6 \, V}{200 \, mA} = 3 \, \Omega \tag{11}$$

Equation 12 shows how to calculate the DAC code for a given output voltage, reference, and gain setting.

$$DAC_DATA = \frac{V_{OUT} \times 2^N}{V_{REF} \times GAIN}$$
(12)

Equation 13 calculates the DAC code for an output voltage, V_{SET} , of 0.6V, the internal 1.21-V reference, and the 1.5 × gain setting.

$$DAC_DATA = \frac{0.6 V \times 2^{12}}{1.21 V \times 1.5} = 1354d$$
(13)

The GPIO pin can be configured as an input to trigger the DACx3x04W output to turn on and off, which turns the current source on and off. Configure the GPIO in the GPIO-CONFIG register. The GPI-EN bit enables the GPIO pin as an input. The GPI-CH-SEL field selects which channels are controlled by the GPI. The GPI-CONFIG field selects the GPI function. Table 7-18 defines the functions for the GPI-CONFIG field. Choose the trigger margin-high or margin-low function if programmable slew is needed, or VOUT power up or down if programmable slew is not needed.

The programmable slew is configured by the CODE-STEP and SLEW-RATE fields in the DAC-X-FUNC-CONFIG Register. The programmable slew is only available when toggling between two values stored in the DAC-X-MARGIN-HIGH and DAC-X-MARGIN-LOW Registers. Section 7.4.5.1.2 discusses how to set the programmable slew. This application example uses a SLEW-RATE of 8 μ V/s and a CODE-STEP of 8-LSB to achieve a 1.36-ms slew time.



The pseudo code for this application example is as follows:

//SYNTAX: WRITE <REGISTER NAME (Hex code)>, <MSB DATA>, <LSB DATA> //Set gain setting to 1.5x internal reference (1.8 V) (repeat for all channels) WRITE DAC-0-VOUT-CMP-CONFIG(0x3), 0x08, 0x00 //Power-up voltage output on all channels and enable the internal reference WRITE COMMON-CONFIG(0x1F),0x12, 0x49 //Configure GPI for Margin-High, Low trigger for all channels WRITE GPIO-CONFIG(0x24), 0x01, 0xF5 //Set slew rate and code step (repeat for all channels) //CODE STEP: 8 LSB, SLEW RATE: 8 µs/step WRITE $\overline{D}AC-0$ -FUNC-CONFIG($\overline{0}x06$), 0x00, 0x52 //Write DAC margin high code (repeat for all channels) //For a 1.8-V output range, the 12-bit hex code for 0.6 V is 0x54A. With 16-bit left alignment, this becomes 0x54A0 WRITE DAC-0-MARGIN-HIGH(0x01), 0x54, 0xA0 //Write DAC margin low code (repeat for all channels) //The 12-bit hex code for 0 V is 0x000. With 16-bit left alignment, this becomes 0x0000 WRITE DAC-0-MARGIN-LOW(0x02), 0x00, 0x00 //Save settings to NVM WRITE COMMON-TRIGGER(0x20), 0x00, 0x02

8.2.3 Application Curve

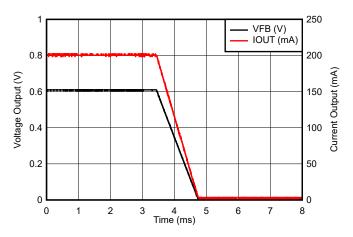


Figure 8-2. IOUT and VFB On-to-Off Transition



8.3 Power Supply Recommendations

The DACx3004W family of devices does not require specific power-supply sequencing. These devices require a single power supply, V_{DD} . However, make sure the external voltage reference is applied after VDD. Use a 0.1- μ F decoupling capacitor for the V_{DD} pin. Use a bypass capacitor with a value approximately 1.5 μ F for the CAP pin.

8.4 Layout

8.4.1 Layout Guidelines

The DACx3004W pin configuration separates the analog, digital, and power pins for an optimized layout. For signal integrity, separate the digital and analog traces, and place decoupling capacitors close to the device pins.

8.4.2 Layout Example

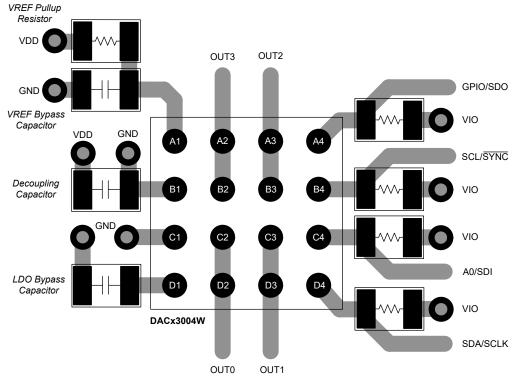


Figure 8-3. Layout Example

Note: The ground and power planes have been omitted for clarity.



9 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

9.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

9.2 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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9.3 Trademarks

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9.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

9.5 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



PACKAGING INFORMATION

| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan (2) | Lead finish/ Ball material | MSL Peak Temp (3) | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|---------------|--------------|--------------------|------|----------------|-----------------|-------------------------------|----------------------|--------------|-------------------------|---------|
| | | | | | | | (6) | | | | |
| DAC53004YBHR | ACTIVE | DSBGA | YBH | 16 | 3000 | RoHS & Green | SNAGCU | Level-1-260C-UNLIM | -40 to 125 | DAC 53004 | Samples |
| DAC63004YBHR | ACTIVE | DSBGA | YBH | 16 | 3000 | RoHS & Green | SNAGCU | Level-1-260C-UNLIM | -40 to 125 | DAC 63004 | Samples |

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE OPTION ADDENDUM



Texas

STRUMENTS

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



| *All dimensions are nominal | | | | | | | | | | | | |
|-----------------------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| Device | Package Type | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
| DAC53004YBHR | DSBGA | YBH | 16 | 3000 | 180.0 | 8.4 | 1.94 | 1.94 | 0.69 | 4.0 | 8.0 | Q1 |
| DAC63004YBHR | DSBGA | YBH | 16 | 3000 | 180.0 | 8.4 | 1.94 | 1.94 | 0.69 | 4.0 | 8.0 | Q1 |



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PACKAGE MATERIALS INFORMATION

30-Jul-2023



*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|--------------|--------------|-----------------|------|------|-------------|------------|-------------|
| DAC53004YBHR | DSBGA | YBH | 16 | 3000 | 182.0 | 182.0 | 20.0 |
| DAC63004YBHR | DSBGA | ҮВН | 16 | 3000 | 182.0 | 182.0 | 20.0 |

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